LOW-POWER, 14-BIT, 1MHz, SINGLE/DUAL UNIPOLAR INPUT, ANALOG-TO-DIGITAL CONVERTERS WITH SERIAL INTERFACE

FEATURES

- **2.7V to 5.5V Analog Supply, Low Power:**
  - **13.7mW (1MHz, +VA = 3V, +VBD = 1.8V)**
- **1MHz Sampling Rate 3V ≤ +VA ≤ 5.5V, 900kHz Sampling Rate 2.7V ≤ +VA ≤ 3V**
- **Excellent DC Performance:**
  - **±0.4LSB Typ, ±1.0LSB Max INL**
  - **±0.4LSB Typ, ±1.0LSB Max DNL**
  - **±0.8mV Max Offset Error at 3V**
  - **±1.25mV Max Offset Error at 5V**
- **Excellent AC Performance at f_I = 10kHz with 85.9dB SNR, 105.3dB SFDR, –100.1dB THD**
- **Built-In Conversion Clock (CCLK)**
- **1.65V to 5.5V I/O Supply:**
  - **SPI™/DSP-Compatible Serial Interface**
  - **SCLK up to 50MHz**
- **Comprehensive Power-Down Modes:**
  - **Deep Power-Down**
  - **Nap Power-Down**
  - **Auto Nap Power-Down**
- **Unipolar Input Range: 0V to V_{REF}**
- **Software Reset**
- **Global $\overline{\text{CONVST}}$ (Independent of $\overline{\text{CS}}$)**
- **Programmable Status/Polarity EOC/$\overline{\text{INT}}$**
- **4 × 4 QFN-16 and TSSOP-16 Packages**
- **Multi-Chip Daisy-Chain Mode**
- **Programmable TAG Bit Output**
- **Auto/Manual Channel Select Mode (ADS7280)**

APPLICATIONS

- **Communications**
- **Transducer Interface**
- **Medical Instruments**
- **Magnetometers**
- **Industrial Process Control**
- **Data Acquisition Systems**
- **Automatic Test Equipment**

DESCRIPTION

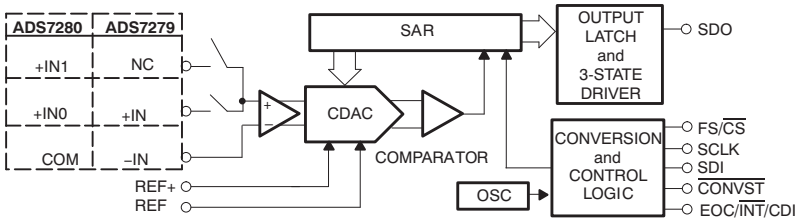
The ADS7279 is a low-power, 14-bit, 1MSPS analog-to-digital converter (ADC) with a unipolar input. The device includes a 14-bit, capacitor-based successive approximation register (SAR) ADC with inherent sample-and-hold.

The ADS7280 is based on the same core and includes a 2-to-1 input MUX with a programmable TAG bit output option. Both the ADS7279 and ADS7280 offer a high-speed, wide voltage serial interface, and are capable of daisy-chain mode operation when multiple converters are used.

These converters are available in 4 × 4 QFN and TSSOP-16 packages, and are fully specified for operation over the industrial –40°C to +85°C temperature range.

Low Power, High-Speed SAR Converter Family

Type/Speed		500 kSPS	1 MSPS
16-bit single-ended	Single	ADS8327	ADS8329
	Dual	ADS8328	ADS8330
14-bit single-ended	Single		ADS7279
	Dual		ADS7280
12-bit single-ended	Single		ADS7229
	Dual		ADS7230



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

ORDERING INFORMATION(1)

MODEL	MAXIMUM INTEGRAL LINEARITY (LSB)	MAXIMUM DIFFERENTIAL LINEARITY (LSB)	MAXIMUM OFFSET ERROR (mV)	PACKAGE TYPE	PACKAGE DESIGNATOR	TEMPERATURE RANGE	ORDERING INFORMATION	TRANSPORT MEDIA, QUANTITY
ADS7279I	±1	±1	±1.25	4 × 4 QFN-16	RSA	–40°C to +85°C	ADS7279IRSAT	Small tape and reel, 250
							ADS7279IRSAR	Tape and reel, 3000
				TSSOP-16	PW		ADS7279IPW	Tube, 90
							ADS7279IPWR	Tape and reel, 2000
ADS7280I	±1	±1	±1.25	4 × 4 QFN-16	RSA	–40°C to +85°C	ADS7280IRSAT	Small tape and reel, 250
							ADS7280IRSAR	Tape and reel, 3000
				TSSOP-16	PW		ADS7280IPW	Tube, 90
							ADS7280IPWR	Tape and reel, 2000

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

ABSOLUTE MAXIMUM RATINGS(1)

Over operating free-air temperature range, unless otherwise noted.

			ADS7279, ADS7280	UNIT
	Voltage	+IN to AGND	–0.3 to +VA + 0.3	V
		–IN to AGND	–0.3 to +VA + 0.3	V
	Voltage range	+VA to AGND	–0.3 to 7	V
		+REF to AGND	–0.3 to +VA + 0.3	V
		–REF to AGND	–0.3 to 0.3	V
		+VBD to BDGND	–0.3 to 7	V
		AGND to BDGND	–0.3 to 0.3	V
	Digital input voltage to BDGND		–0.3 to +VBD + 0.3	V
	Digital output voltage to BDGND		–0.3 to +VBD + 0.3	V
T_A	Operating free-air temperature range		–40 to +85	°C
T_{stg}	Storage temperature range		–65 to +150	°C
T_J max	Junction temperature		+150	°C
	4 × 4 QFN-16 package	Power dissipation	$(T_J max – T_A)/\theta_{JA}$	
		θ_{JA} thermal impedance	47	°C/W
	TSSOP-16 package	Power dissipation	$(T_J max – T_A)/\theta_{JA}$	
		θ_{JA} thermal impedance	86	°C/W

(1) Stresses beyond those listed under *absolute maximum ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *recommended operating conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

At T_A = –40°C to +85°C, +VA = 4.5V to 5.5V, +VBD = +1.65V to +5.5V, V_{REF} = 5V, and f_{SAMPLE} = 1MHz, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADS7279, ADS7280 MIN	TYP	MAX	UNIT
ANALOG INPUT						
FSR	Full-scale input voltage(1)	+IN – (–IN) or (+INx – COM)	0		V_{REF}	V
	Absolute input voltage	+IN, +IN0, +IN1	AGND – 0.2		+VA + 0.2	V
		–IN or COM	AGND – 0.2		AGND + 0.2	
	Input capacitance				45	pF
	Input leakage current	No ongoing conversion, dc input		50		nA
	Input channel isolation, ADS7280 only	At dc		109		dB
		V_I = ±1.25V_{PP} at 50kHz		101		
SYSTEM PERFORMANCE						
	Resolution			14		Bits
NMC	No missing codes		14			Bits
INL	Integral linearity		–1	±0.4	1	LSB(2)
DNL	Differential linearity		–1	±0.4	1	LSB(2)
E_O	Offset error(3)		–1.25	±0.3	1.25	mV
	Offset error drift	FSR = 5V		±0.2		ppm/°C
E_G	Gain error		–0.25	±0.05	0.25	%FSR
	Gain error drift			±0.5		ppm/°C
CMRR	Common-mode rejection ratio	At dc		70		dB
		V_I = 0.4V_{PP} at 1MHz		50		
	Noise			33		μV_{RMS}
PSRR	Power-supply rejection ratio	At FFFFh output code(3)		78		dB
SAMPLING DYNAMICS						
t_{CONV}	Conversion time			18		CCLK
$t_{SAMPLE1}$	Acquisition time	Manual trigger	3			CCLK
$t_{SAMPLE2}$		Auto trigger		3		
	Throughput rate				1	MHz
	Aperture delay			5		ns
	Aperture jitter			10		ps
	Step response			100		ns
	Overvoltage recovery			100		ns

(1) Ideal input span; does not include gain or offset error.
(2) LSB means least significant bit.
(3) Measured relative to an ideal full-scale input [(+IN) – (–IN)] of 4.096V when +VA = 5V.

ELECTRICAL CHARACTERISTICS (continued)

At T_A = –40°C to +85°C, +VA = 4.5V to 5.5V, +VBD = +1.65V to +5.5V, V_{REF} = 5V, and f_{SAMPLE} = 1MHz, unless otherwise noted.

PARAMETER			TEST CONDITIONS	ADS7279, ADS7280 MIN	TYP	MAX	UNIT
DYNAMIC CHARACTERISTICS							
THD	Total harmonic distortion(4)		V_{IN} = $5V_{PP}$ at 10kHz		–100.1		dB
			V_{IN} = $5V_{PP}$ at 100kHz		–89.1		
SNR	Signal-to-noise ratio		V_{IN} = $5V_{PP}$ at 10kHz		85.9		dB
			V_{IN} = $5V_{PP}$ at 100kHz	81.0	84.3		
SINAD	Signal-to-noise + distortion		V_{IN} = $5V_{PP}$ at 10kHz		85.7		dB
			V_{IN} = $5V_{PP}$ at 100kHz		82.7		
SFDR	Spurious-free dynamic range		V_{IN} = $5V_{PP}$ at 10kHz		105.3		dB
			V_{IN} = $5V_{PP}$ at 100kHz		91.3		
	–3dB small-signal bandwidth				30		MHz
CLOCK							
	Internal conversion clock frequency			21	23	24.5	MHz
	SCLK external serial clock		Used as I/O clock only			50	MHz
			As I/O clock and conversion clock	1		42	
EXTERNAL VOLTAGE REFERENCE INPUT							
V_{REF}	Input reference range	V_{REF}[REF+ – (REF–)]		0.3		+VA	V
		(REF–) – AGND		–0.1		0.1	
	Resistance(5)		Reference input		40		kΩ
DIGITAL INPUT/OUTPUT							
	Logic family—CMOS						
V_{IH}	High-level input voltage		5.5V ≥ +VBD ≥ 4.5V	0.65 × (+VBD)		+VBD + 0.3	V
V_{IL}	Low-level input voltage		5.5V ≥ +VBD ≥ 4.5V	–0.3		0.35 × (+VBD)	V
I_I	Input current		V_I = +VBD or BDGND	–50		50	nA
C_I	Input capacitance				5		pF
V_{OH}	High-level output voltage		5.5V ≥ +VBD ≥ 4.5V, I_O = 100µA	+VBD – 0.6		+VBD	V
V_{OL}	Low-level output voltage		5.5V ≥ +VBD ≥ 4.5V, I_O = 100µA	0		0.4	V
C_O	Output capacitance				5		pF
C_L	Load capacitance					30	pF
	Data format—straight binary						
POWER-SUPPLY REQUIREMENTS							
	Power-supply voltage	+VBD		1.65	3.3	5.5	V
		+VA		4.5	5	5.5	V
	Supply current		1MHz Sample rate		5.7	7.0	mA
			Nap or Auto Nap mode		0.3	0.5	
			Deep power-down mode		0.004	1	µA
	Buffer I/O supply current		1MSPS, BVDD = 1.8V		0.1	0.5	mA
			1MSPS, BVDD = 3V		0.5	1.2	
	Power dissipation		AVDD = 5V, BVDD = 1.8V		28.7	35.9	mW
			AVDD = 5V, BVDD = 3V		30.0	38.6	
TEMPERATURE RANGE							
T_A	Operating free-air temperature			–40		+85	°C

(4) Calculated on the first nine harmonics of the input frequency.
(5) Can vary ±30%.

ELECTRICAL CHARACTERISTICS

At T_A = –40°C to +85°C, +VA = 2.7V to 3.6V, +VBD = 1.65V to 1.5x(+VA), V_{REF} = 2.5V, f_{SAMPLE} = 1MHz for 3V ≤ +VA ≤ 3.6V, and f_{SAMPLE} = 900kHz for 3V < +VA ≤ 2.7V using external clock, unless otherwise noted.

PARAMETER		TEST CONDITIONS	ADS7279, ADS7280			UNIT
			MIN	TYP	MAX	
ANALOG INPUT						
FSR	Full-scale input voltage(1)	+IN – (–IN) or (+INx – COM)	0		V_{REF}	V
	Absolute input voltage	+IN, +IN0, +IN1	AGND – 0.2		+VA + 0.2	V
		–IN or COM	AGND – 0.2		AGND + 0.2	
	Input capacitance				45	pF
	Input leakage current	No ongoing conversion, dc Input		50		nA
	Input channel isolation, ADS7280 only	At dc		108		dB
		V_{IN} = ±1.25V_{PP} at 50kHz		101		
SYSTEM PERFORMANCE						
	Resolution			14		Bits
	No missing codes		14			Bits
INL	Integral linearity		–1	±0.4	1	LSB(2)
DNL	Differential linearity		–1	±0.4	1	LSB(2)
E_O	Offset error(3)		–0.8	±0.05	0.8	mV
	Offset error drift	FSR = 2.5V		±0.1		ppm/°C
E_G	Gain error		–0.25	±0.06	0.25	%FSR
	Gain error drift			±0.5		ppm/°C
CMRR	Common-mode rejection ratio	At dc		70		dB
		V_{IN} = 0.4V_{PP} at 1MHz		50		
	Noise			33		μV_{RMS}
PSRR	Power-supply rejection ratio	At FFFFh output code(3)		78		dB
SAMPLING DYNAMICS						
t_{CONV}	Conversion time			18		CCLK
$t_{SAMPLE1}$	Acquisition time	Manual trigger	3			CCLK
$t_{SAMPLE2}$		Auto trigger		3		
	Throughput rate	2.7V ≤ +VA < 3.0V			0.9	MHz
		3.0V ≤ +VA < 3.64V			1	
	Aperture delay			5		ns
	Aperture jitter			10		ps
	Step response			100		ns
	Overvoltage recovery			100		ns

(1) Ideal input span; does not include gain or offset error.
(2) LSB means least significant bit.
(3) Measured relative to an ideal full-scale input [(+IN) – (–IN)] of 2.5V when +VA = 3V.

ELECTRICAL CHARACTERISTICS (continued)

At T_A = –40°C to +85°C, +VA = 2.7V to 3.6V, +VBD = 1.65V to 1.5x(+VA), V_{REF} = 2.5V, f_{SAMPLE} = 1MHz for 3V ≤ +VA ≤ 3.6V, and f_{SAMPLE} = 900kHz for 3V < +VA ≤ 2.7V using external clock, unless otherwise noted.

PARAMETER			TEST CONDITIONS	ADS7279, ADS7280 MIN	TYP	MAX	UNIT
DYNAMIC CHARACTERISTICS							
THD	Total harmonic distortion(4)		V_{IN} = 2.5V_{PP} at 10kHz		–100.8		dB
			V_{IN} = 2.5V_{PP} at 100kHz		–88.4		
SNR	Signal-to-noise ratio		V_{IN} = 2.5V_{PP} at 10kHz	81	83.1		dB
			V_{IN} = 2.5V_{PP} at 100kHz		82		
SINAD	Signal-to-noise + distortion		V_{IN} = 2.5V_{PP} at 10kHz		83		dB
			V_{IN} = 2.5V_{PP} at 100kHz		81.4		
SFDR	Spurious-free dynamic range		V_{IN} = 2.5V_{PP} at 10kHz		102.6		dB
			V_{IN} = 2.5V_{PP} at 100kHz		89.8		
	–3dB small-signal bandwidth				30		MHz
CLOCK							
	Internal conversion clock frequency			21	22	23.5	MHz
	SCLK external serial clock		Used as I/O clock only			42	MHz
			As I/O clock and conversion clock	1		42	
EXTERNAL VOLTAGE REFERENCE INPUT							
V_{REF}	Input reference range	V_{REF} [REF+ – (REF–)]	f_{SAMPLE} ≤ 500kSPS, 2.7V ≤ +VA < 3V	0.3		2.525	V
			f_{SAMPLE} ≤ 500kSPS, 3V ≤ +VA < 3.6V	0.3		3	
			f_{SAMPLE} > 500kSPS, 2.7V ≤ +VA < 3V	2.475		2.525	
			f_{SAMPLE} > 500kSPS, 3V ≤ +VA < 3.6V	2.475		3	
		(REF–) – AGND		–0.1		0.1	
	Resistance(5)		Reference input		40		kΩ
DIGITAL INPUT/OUTPUT							
	Logic family—CMOS						
V_{IH}	High-level input voltage		(+VA × 1.5)V ≥ +VBD ≥ 1.65V	0.65 × (+VBD)		+VBD + 0.3	V
V_{IL}	Low-level input voltage		(+VA × 1.5)V ≥ +VBD ≥ 1.65V	–0.3		0.35 × (+VBD)	V
I_I	Input current		V_I = +VBD or BDGND	–50		50	nA
C_I	Input capacitance				5		pF
V_{OH}	High-level output voltage		(+VA × 1.5)V ≥ +VBD ≥ 1.65V, I_O = 100µA	+VBD – 0.6		+VBD	V
V_{OL}	Low-level output voltage		(+VA × 1.5)V ≥ +VBD ≥ 1.65V, I_O = 100µA	0		0.4	V
C_O	Output capacitance				5		pF
C_L	Load capacitance					30	pF
	Data format—straight binary						

(4) Calculated on the first nine harmonics of the input frequency.
(5) Can vary ±30%.

ELECTRICAL CHARACTERISTICS (continued)

At T_A = –40°C to +85°C, +VA = 2.7V to 3.6V, +VBD = 1.65V to 1.5x(+VA), V_{REF} = 2.5V, f_{SAMPLE} = 1MHz for 3V ≤ +VA ≤ 3.6V, and f_{SAMPLE} = 900kHz for 3V < +VA ≤ 2.7V using external clock, unless otherwise noted.

PARAMETER			TEST CONDITIONS	ADS7279, ADS7280 MIN	TYP	MAX	UNIT
POWER-SUPPLY REQUIREMENTS							
	Power-supply voltage	+VBD		1.65	+VA	1.5 × (+VA)	V
		+VA	f_S ≤ 1MHz	3		3.6	V
			f_S ≤ 900kHz	2.7		3.6	
	Supply current		1MHz sample rate, 3V ≤ +VA ≤ 3.6V		4.5	6.0	mA
			900kHz sample rate, 2.7V ≤ +VA ≤ 3V		4.2		
			Nap or Auto Nap mode		0.25	0.4	
			Deep power-down mode		0.001	1	µA
	Buffer I/O supply current		1MSPS, BVDD = 1.8V		0.1	0.5	mA
			1MSPS, BVDD = 3V		0.5	1.2	
	Power dissipation		AVDD = 3V, BVDD = 1.8V		13.7	18.9	mW
			AVDD = 3V, BVDD = 3V		15.0	21.6	
TEMPERATURE RANGE							
T_A	Operating free-air temperature			–40		+85	°C

TIMING CHARACTERISTICS[1][2]: 5V

All specifications typical at –40°C to +85°C and +VA = +VBD = 5V, unless otherwise noted.

PARAMETER			ADS7279, ADS7280			UNIT
			MIN	TYP	MAX	
f_{CCLK}	Frequency, conversion clock, CCLK	External, f_{CCLK} = 1/2 f_{SCLK}	0.5		21	MHz
		Internal, f_{CCLK} = 1/2 f_{SCLK}	21	23	24.5	
t_1	Setup time, falling edge of $\overline{CS}$ to EOC		1			CCLK
t_2	Hold time, falling edge of $\overline{CS}$ to EOC		0			ns
t_{CL}	Pulse duration, $\overline{CONVST}$ low		40			ns
t_3	Hold time, falling edge of $\overline{CS}$ to EOS		20			ns
t_4	Setup time, rising edge of $\overline{CS}$ to EOS		20			ns
t_5	Hold time, rising edge of $\overline{CS}$ to EOS		20			ns
t_6	Setup time, falling edge of $\overline{CS}$ to first falling SCLK		5			ns
t_{SCLKL}	Pulse duration, SCLK low		8		t_{SCLK} – 8	ns
t_{SCLKH}	Pulse duration, SCLK high		8		t_{SCLK} – 8	ns
t_{SCLK}	Cycle time, SCLK	I/O clock only	20			ns
		I/O and conversion clock	23.8		2000	
		I/O clock, chain mode	20			
		I/O and conversion clock, chain mode	23.8		2000	
t_{H2}	Hold time, falling edge of SCLK to SDO invalid	10pF load	2			ns
t_{D1}	Delay time, falling edge of SCLK to SDO valid	10pF load			10	ns
t_{D2}	Delay time, falling edge of $\overline{CS}$ to SDO valid, SDO MSB output	10pF load			8.5	ns
t_{S1}	Setup time, SDI to falling edge of SCLK		8			ns
t_{H1}	Hold time, SDI to falling edge of SCLK		4			ns
t_{D3}	Delay time, rising edge of $\overline{CS}$/FS to SDO t_{D3} 3-state				5	ns
t_7	Setup time, 16th falling edge of SCLK before rising edge of $\overline{CS}$/FS		10			ns

(1) All input signals are specified with $t_r = t_f$ = 1.5ns (10% to 90% of VBD) and timed from a voltage level of $(V_{IL} + V_{IH})/2$.
(2) See timing diagrams.

TIMING CHARACTERISTICS[1][2] : 1.8V

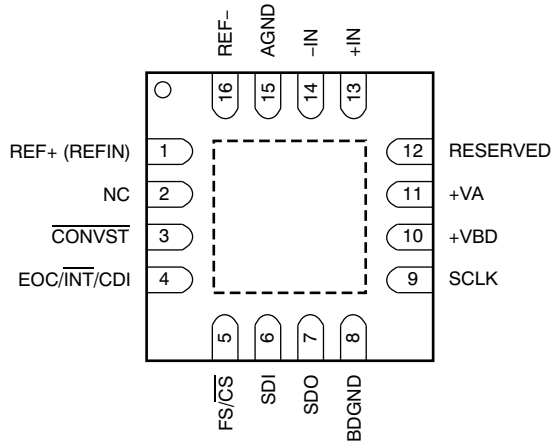
All specifications typical at –40°C to 85°C, +VA = 2.7 V, and +VBD = 1.8V, unless otherwise noted.

PARAMETER			ADS7279, ADS7280			UNIT
			MIN	TYP	MAX	
f_{CCLK}	Frequency, conversion clock, CCLK	External, 3V ≤ +VA ≤ 3.6V, f_{CCLK} = 1/2 f_{SCLK}	0.5		21	MHz
		External, 2.7V ≤ +VA ≤ 3V, f_{CCLK} = 1/2 f_{SCLK}	0.5		18.9	
		Internal, f_{CCLK} = 1/2 f_{SCLK}	20	22	23.5	
t_1	Setup time, falling edge of $\overline{CS}$ to EOC		1			CCLK
t_2	Hold time, falling edge of $\overline{CS}$ to EOC		0			ns
t_{CL}	Pulse duration, $\overline{CONVST}$ low		40			ns
t_3	Hold time, falling edge of $\overline{CS}$ to EOS		20			ns
t_4	Setup time, rising edge of $\overline{CS}$ to EOS		20			ns
t_5	Hold time, rising edge of $\overline{CS}$ to EOS		20			ns
t_6	Setup time, falling edge of $\overline{CS}$ to first t_6 falling SCLK		5			ns
t_{SCLKL}	Pulse duration, SCLK low		8		t_{SCLK} – 8	ns
t_{SCLKH}	Pulse duration, SCLK high		8		t_{SCLK} – 8	ns
t_{SCLK}	Cycle time, SCLK	All modes, 3V ≤ +VA ≤ 3.6V	23.8		2000	ns
		All modes, 2.7V ≤ +VA < 3V	26.5		2000	
t_{H2}	Hold time, falling edge of SCLK to SDO invalid	10pF load	7.5			ns
t_{D1}	Delay time, falling edge of SCLK to SDO valid	10pF load			16	ns
t_{D2}	Delay time, falling edge of $\overline{CS}$ to SDO valid, SDO MSB output	10pF load, 2.7V ≤ +VA ≤ 3V			13	ns
		10pF load, 3V ≤ +VA ≤ 3.6V			11	
t_{S1}	Setup time, SDI to falling edge of SCLK		8			ns
t_{H1}	Hold time, SDI to falling edge of SCLK		4			ns
t_{D3}	Delay time, rising edge of $\overline{CS}$/FS to SDO 3-state				8	ns
t_7	Setup time, 16th falling edge of SCLK t_7 before rising edge of $\overline{CS}$/FS		10			ns

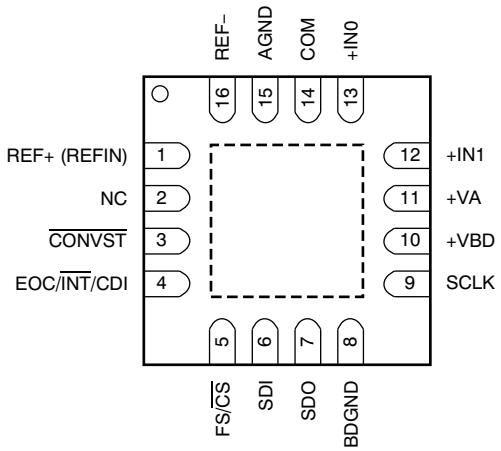
(1) All input signals are specified with t_r = t_f = 1.5ns (10% to 90% of VBD) and timed from a voltage level of (V_{IL} + V_{IH})/2.
(2) See timing diagrams.

PIN ASSIGNMENTS

ADS7279
RSA PACKAGE (QFN)
(TOP VIEW)

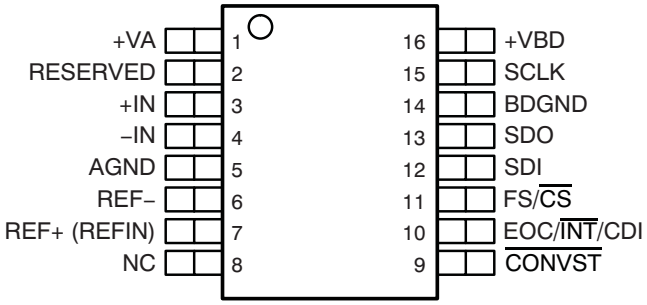


ADS7280
RSA PACKAGE (QFN)
(TOP VIEW)



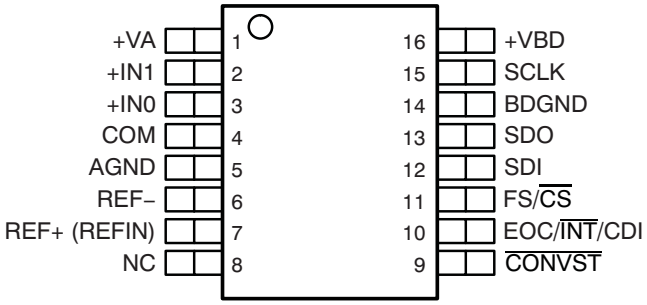
CAUTION: The thermal pad is internally connected to the substrate. This pad can be connected to the analog ground or left floating. Keep the thermal pad separate from the digital ground, if possible.

ADS7279
PW PACKAGE (TSSOP)
(TOP VIEW)



NC = No internal connection

ADS7280
PW PACKAGE (TSSOP)
(TOP VIEW)



ADS7279 Terminal Functions

NAME	NO.		I/O	DESCRIPTION
	QFN	TSSOP		
AGND	15	5	—	Analog ground
BDGND	8	14	—	Interface ground
$\overline{\text{CONVST}}$	3	9	I	Freezes sample-and-hold, starts conversion with next rising edge of internal clock
EOC/ $\overline{\text{INT}}$/ CDI	4	10	I/O	Status output. If programmed as EOC, this pin is low (default) when a conversion is in progress. If programmed as an interrupt ($\overline{\text{INT}}$), this pin is low for a preprogrammed duration after the end of conversion and valid data are to be output. The polarity of EOC or $\overline{\text{INT}}$ is programmable. This pin can also be used as a chain data input when the device is operated in daisy-chain mode.
FS/$\overline{\text{CS}}$	5	11	I	Frame sync signal for TMS320 DSP serial interface or chip select input for SPI interface slave select (SS–).
+IN	13	3	I	Noninverting input
–IN	14	4	I	Inverting input; usually connected to ground
NC	2	8	—	No connection
REF+ (REFIN)	1	7	I	External reference input
REF–	16	6	I	Connect to AGND through individual via
RESERVED	12	2	I	Connect to AGND or +VA
SCLK	9	15	I	Clock for serial interface
SDI	6	12	I	Serial data in
SDO	7	13	O	Serial data out
+VA	11	1		Analog supply, +2.7V to +5.5VDC
+VBD	10	16		Interface supply

ADS7280 Terminal Functions

NAME	NO.		I/O	DESCRIPTION
	QFN	TSSOP		
AGND	15	5	—	Analog ground
BDGND	8	14	—	Interface ground
COM	14	4	I	Common inverting input; usually connected to ground
$\overline{\text{CONVST}}$	3	9	I	Freezes sample-and-hold, starts conversion with next rising edge of internal clock
EOC/ $\overline{\text{INT}}$/ CDI	4	10	I/O	Status output. If programmed as EOC, this pin is low (default) when a conversion is in progress. If programmed as an interrupt ($\overline{\text{INT}}$), this pin is low for a preprogrammed duration after the end of conversion and valid data are to be output. The polarity of EOC or $\overline{\text{INT}}$ is programmable. This pin can also be used as a chain data input when the device is operated in daisy-chain mode.
FS/$\overline{\text{CS}}$	5	11	I	Frame sync signal for TMS320 DSP serial interface or chip select input for SPI interface
+IN1	12	2	I	Second noninverting input
+IN0	13	3	I	First noninverting input
NC	2	8	—	No connection.
REF+ (REFIN)	1	7	I	External reference input
REF–	16	6	I	Connect to AGND through individual via
SCLK	9	15	I	Clock for serial interface
SDI	6	12	I	Serial data in (conversion start and reset possible)
SDO	7	13	O	Serial data out
+VA	11	1		Analog supply, +2.7V to +5.5VDC
+VBD	10	16		Interface supply

MANUAL TRIGGER/READ While Sampling
(use internal CCLK, EOC, and $\overline{INT}$ polarity programmed as active low)

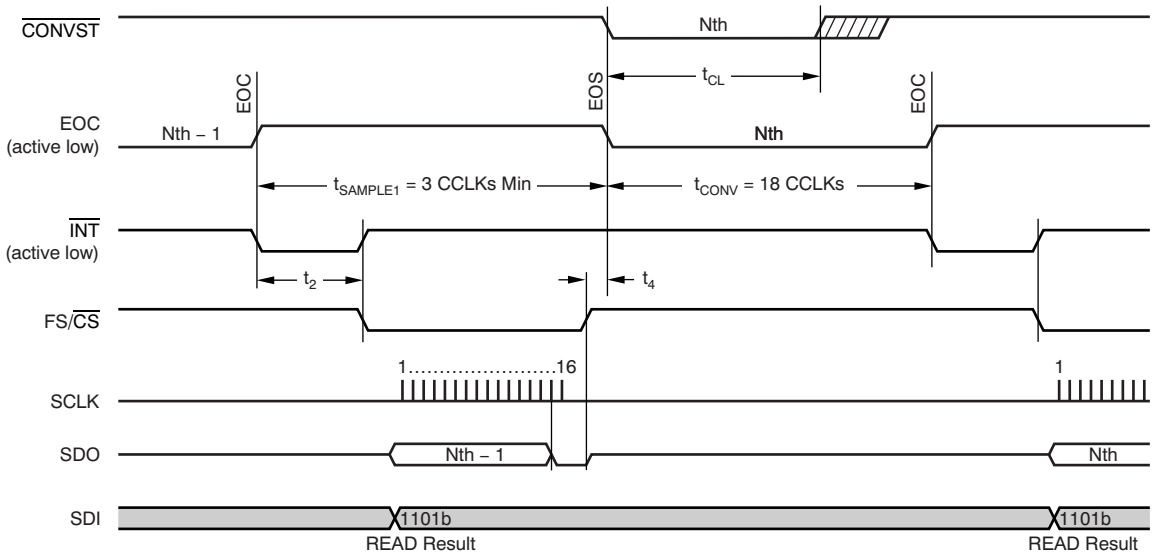


Figure 1. Timing for Conversion and Acquisition Cycles for Manual Trigger (Read While Sampling)

MANUAL TRIGGER/READ While Converting
(use internal CCLK, EOC, and $\overline{INT}$ polarity programmed as active low)

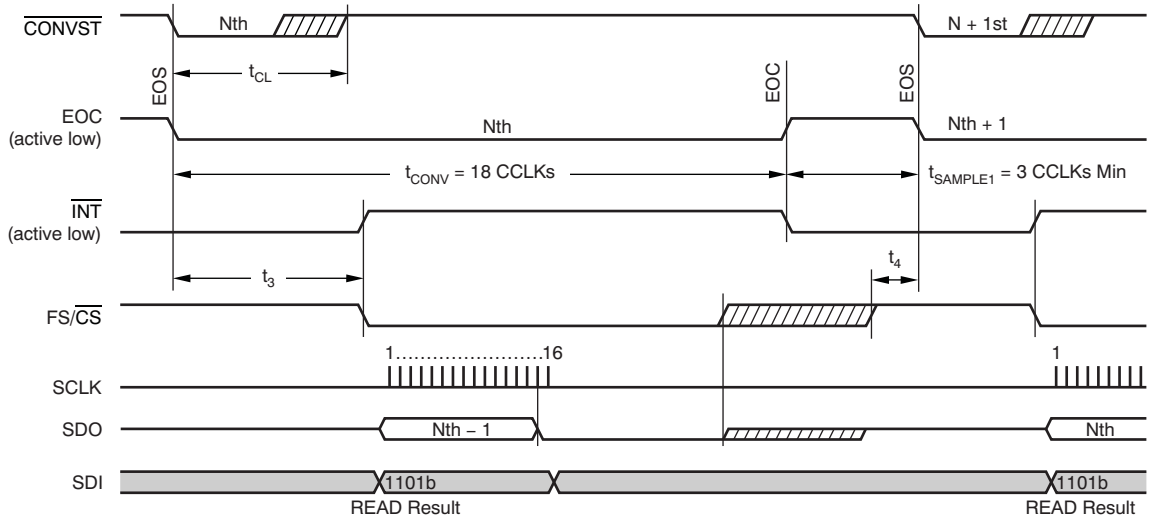


Figure 2. Timing for Conversion and Acquisition Cycles for Manual Trigger (Read While Converting)

AUTO TRIGGER/READ While Converting
(use internal CCLK, EOC, and INT polarity programmed as active low)

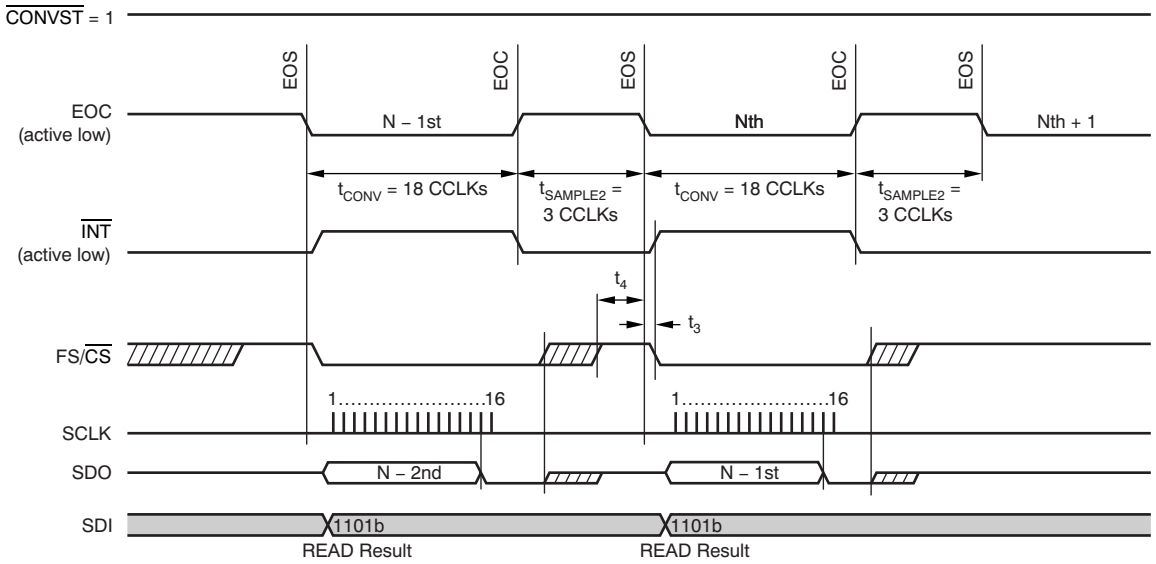


Figure 3. Timing for Conversion and Acquisition Cycles for Autotrigger (Read While Converting)

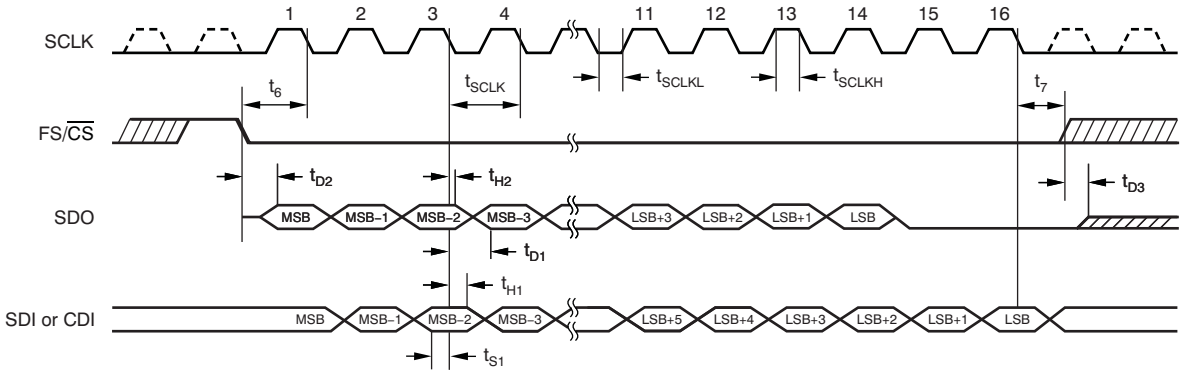


Figure 4. Detailed SPI Transfer Timing

MANUAL TRIGGER/READ While Converting
(use internal CCLK, EOC, and $\overline{INT}$ polarity programmed as active low, TAG enabled, auto channel select)

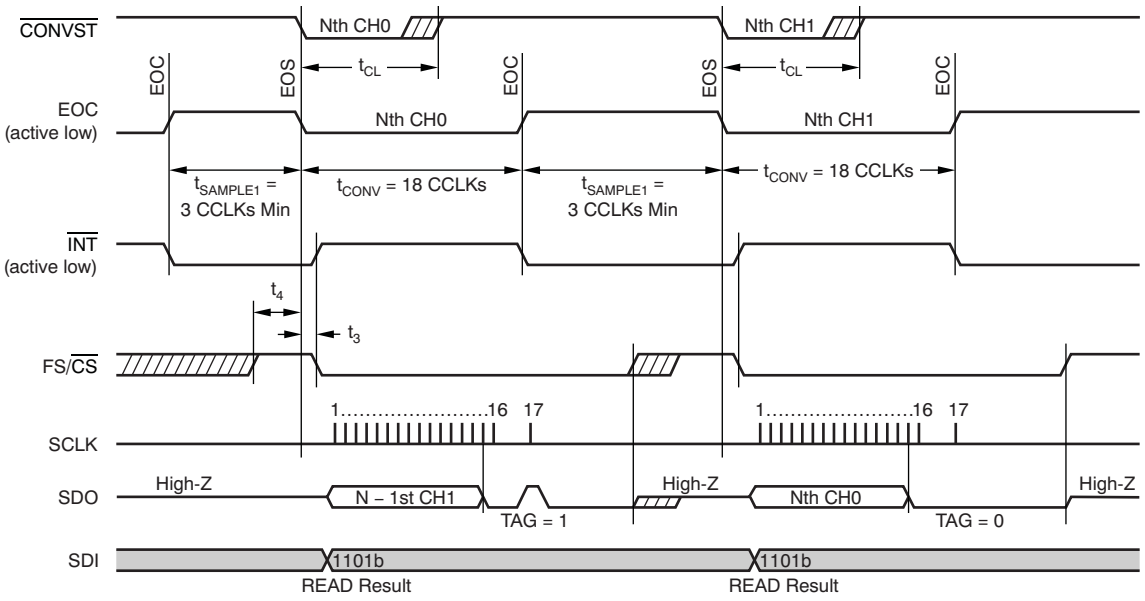


Figure 5. Simplified Dual Channel Timing

TYPICAL CHARACTERISTICS

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

CROSSTALK vs FREQUENCY

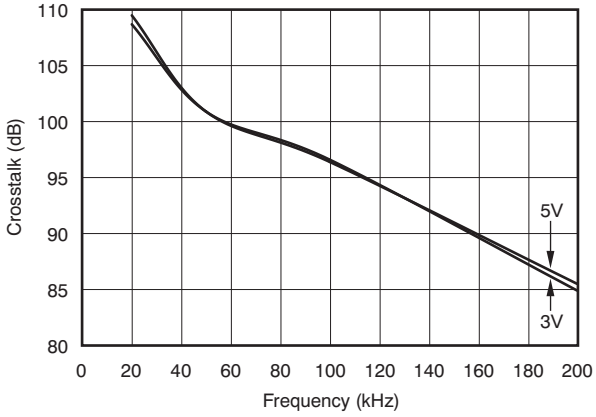


Figure 6.

DIFFERENTIAL NONLINEARITY vs FREE-AIR TEMPERATURE

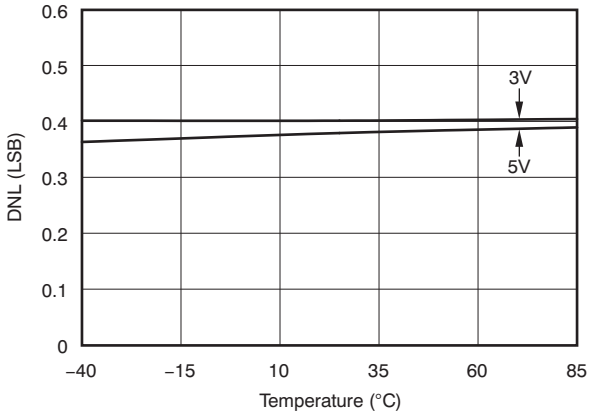


Figure 7.

INTEGRAL NONLINEARITY vs FREE-AIR TEMPERATURE

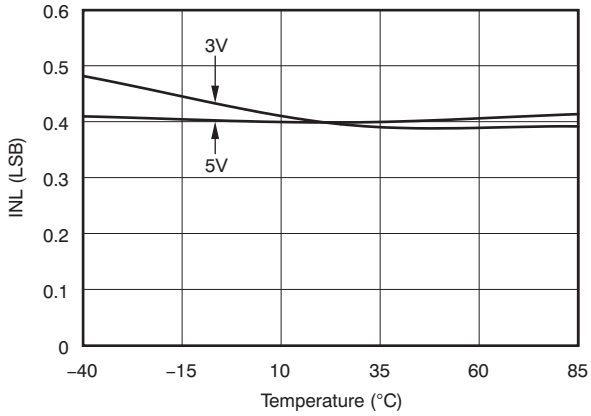


Figure 8.

DIFFERENTIAL NONLINEARITY vs EXTERNAL CLOCK FREQUENCY

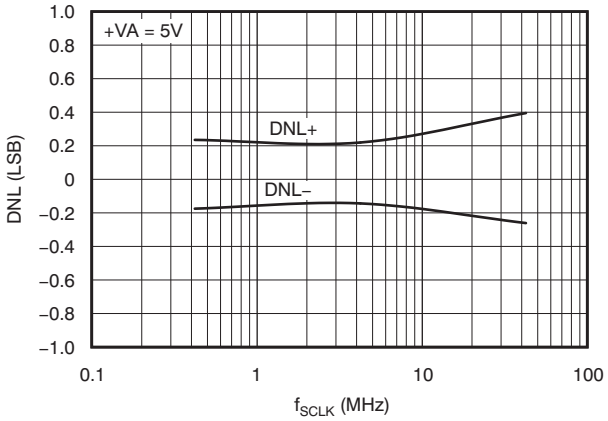


Figure 9.

INTEGRAL NONLINEARITY vs EXTERNAL CLOCK FREQUENCY

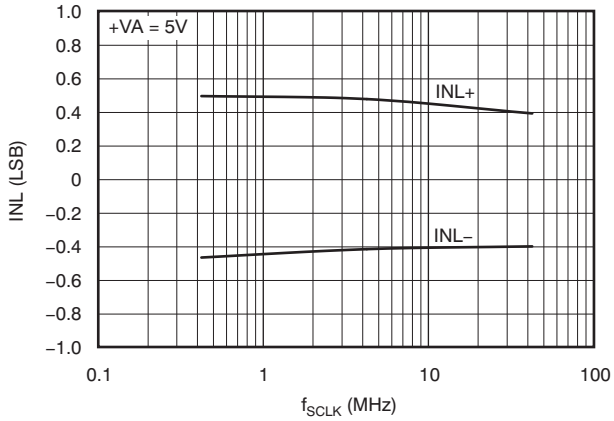


Figure 10.

DIFFERENTIAL NONLINEARITY vs EXTERNAL CLOCK FREQUENCY

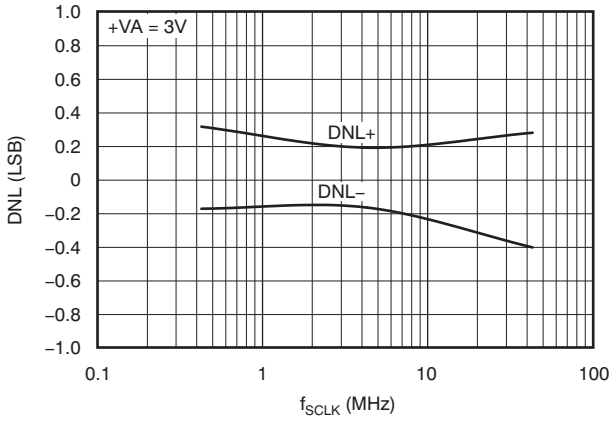


Figure 11.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

INTEGRAL NONLINEARITY vs EXTERNAL CLOCK FREQUENCY

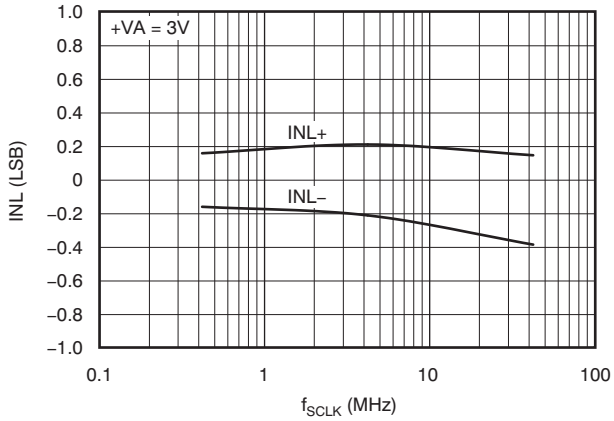


Figure 12.

OFFSET VOLTAGE vs FREE-AIR TEMPERATURE

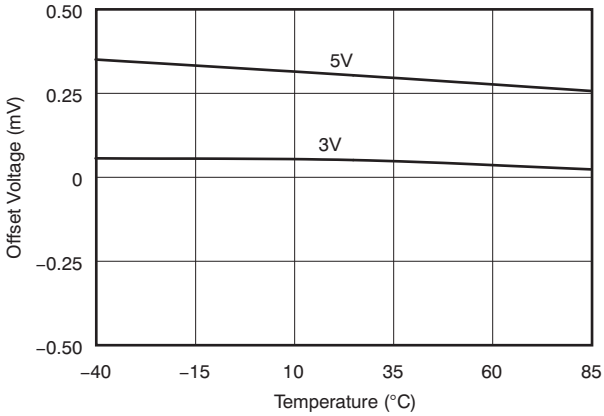


Figure 13.

OFFSET VOLTAGE vs SUPPLY VOLTAGE

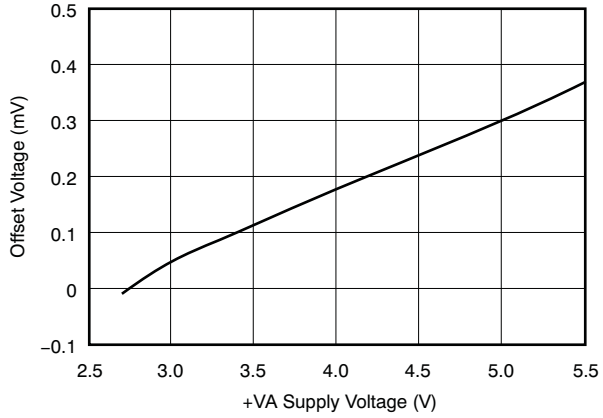


Figure 14.

GAIN ERROR vs FREE-AIR TEMPERATURE

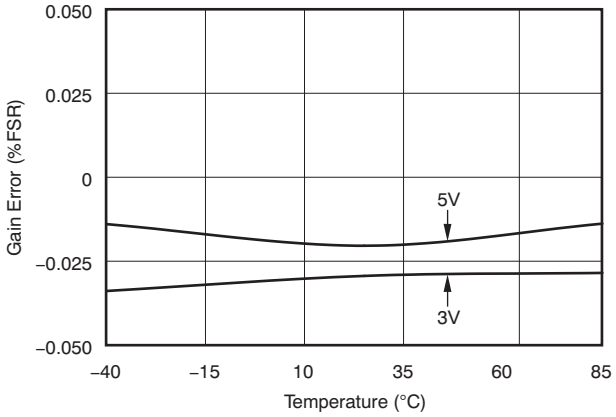


Figure 15.

GAIN ERROR vs SUPPLY VOLTAGE

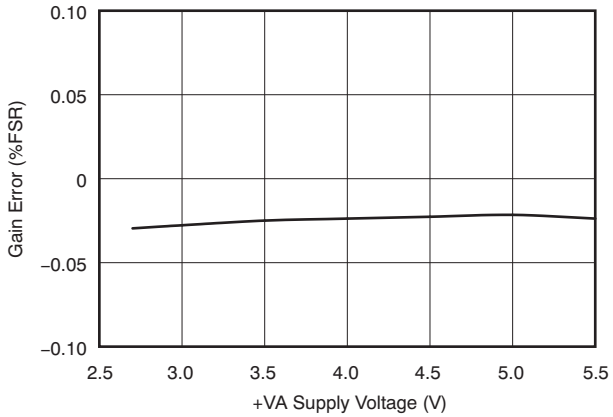


Figure 16.

POWER-SUPPLY REJECTION RATIO vs SUPPLY RIPPLE FREQUENCY

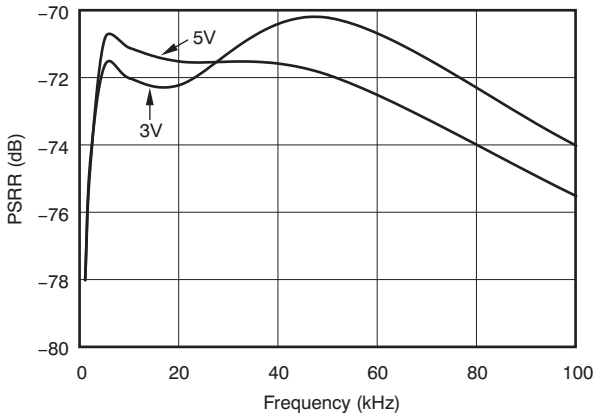


Figure 17.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

SIGNAL-TO-NOISE RATIO vs INPUT FREQUENCY

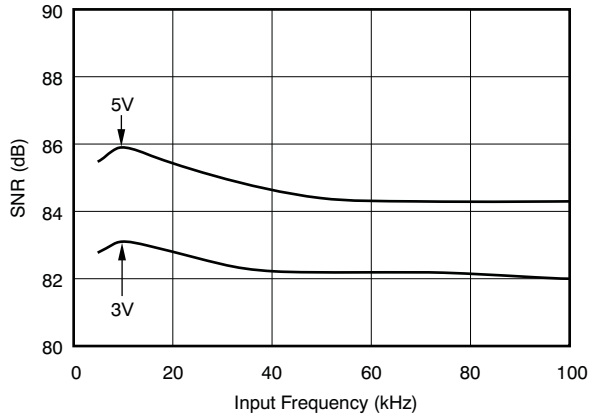


Figure 18.

SIGNAL-TO-NOISE AND DISTORTION vs INPUT FREQUENCY

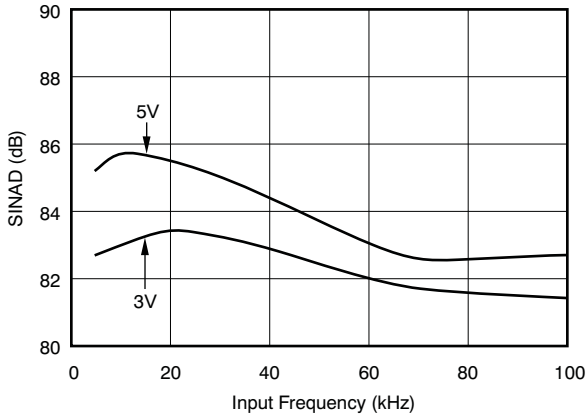


Figure 19.

TOTAL HARMONIC DISTORTION vs INPUT FREQUENCY

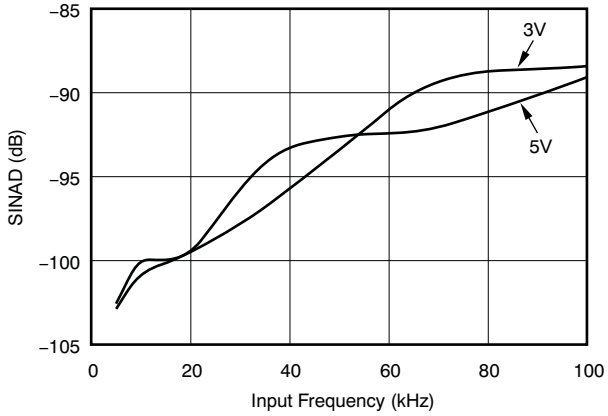


Figure 20.

SPURIOUS-FREE DYNAMIC RANGE vs INPUT FREQUENCY

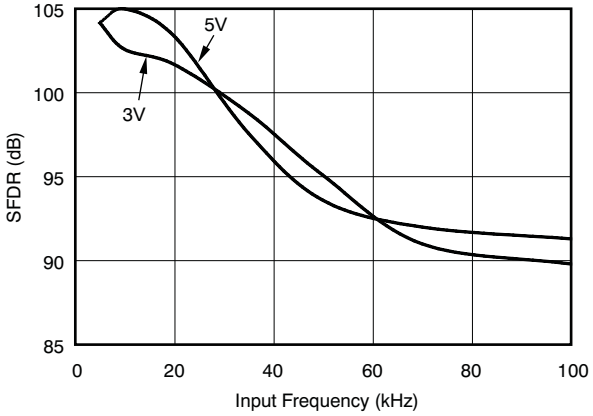


Figure 21.

SIGNAL-TO-NOISE RATIO vs FULL-SCALE RANGE

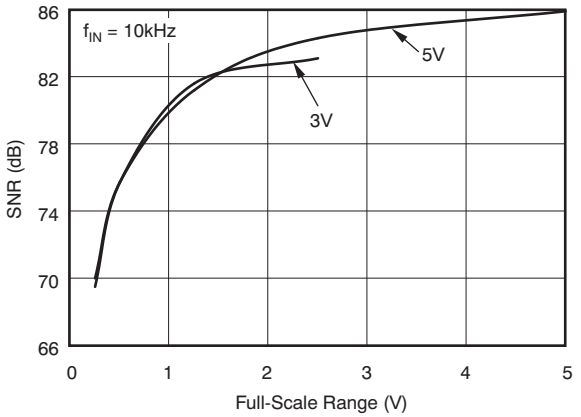


Figure 22.

SIGNAL-TO-NOISE AND DISTORTION vs FULL-SCALE RANGE

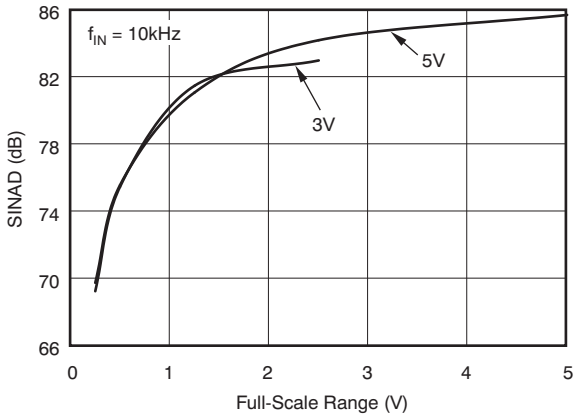


Figure 23.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

TOTAL HARMONIC DISTORTION vs FULL-SCALE RANGE

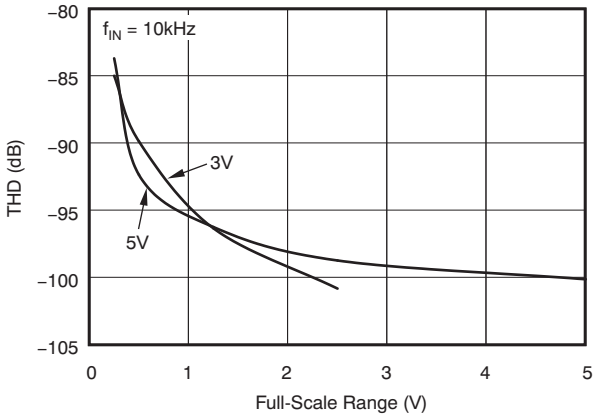


Figure 24.

SPURIOUS-FREE DYNAMIC RANGE vs FULL-SCALE RANGE

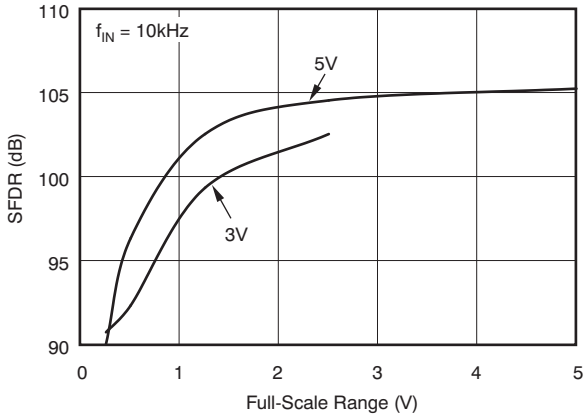


Figure 25.

TOTAL HARMONIC DISTORTION vs FREE-AIR TEMPERATURE

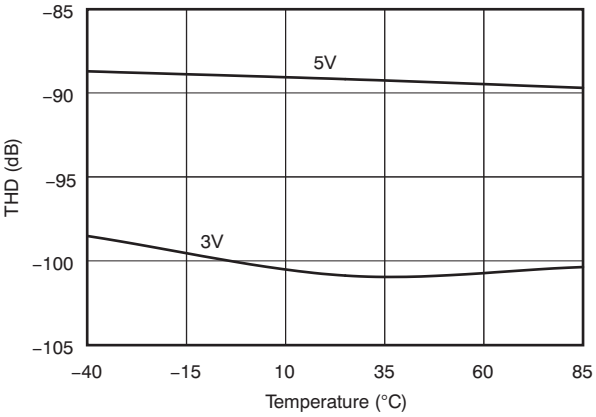


Figure 26.

SPURIOUS-FREE DYNAMIC RANGE vs FREE-AIR TEMPERATURE

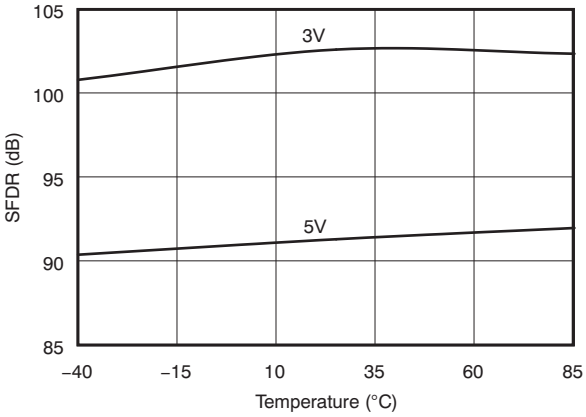


Figure 27.

SIGNAL-TO-NOISE RATIO vs FREE-AIR TEMPERATURE

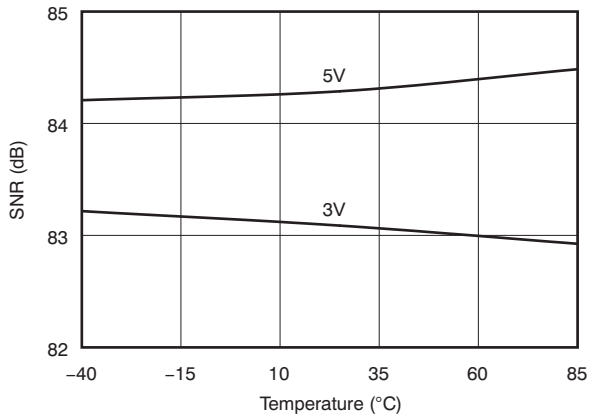


Figure 28.

SIGNAL-TO-NOISE AND DISTORTION vs FREE-AIR TEMPERATURE

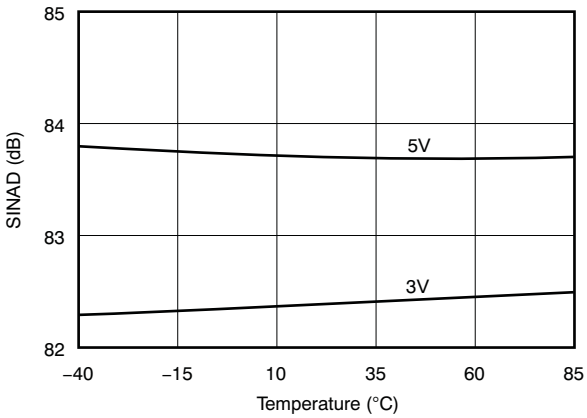


Figure 29.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

EFFECTIVE NUMBER OF BITS vs FREE-AIR TEMPERATURE

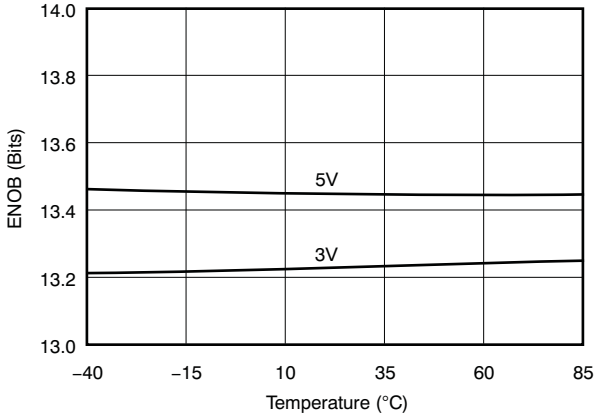


Figure 30.

INTERNAL CLOCK FREQUENCY vs SUPPLY VOLTAGE

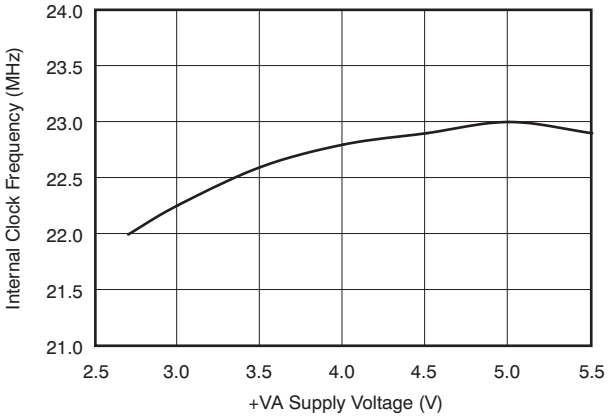


Figure 31.

INTERNAL CLOCK FREQUENCY vs FREE-AIR TEMPERATURE

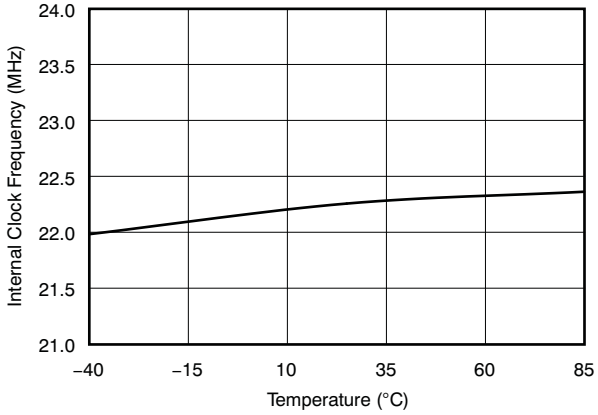


Figure 32.

ANALOG SUPPLY CURRENT vs SUPPLY VOLTAGE

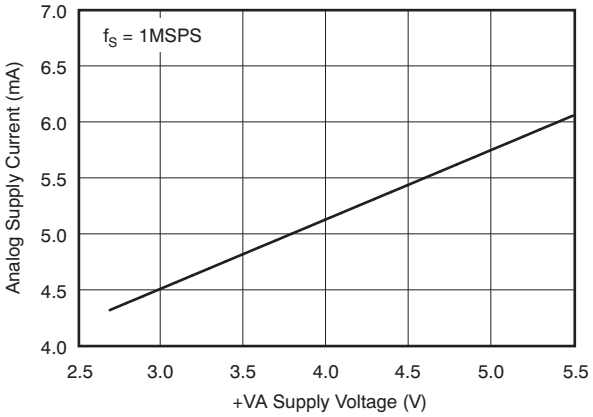


Figure 33.

ANALOG SUPPLY CURRENT vs SUPPLY VOLTAGE

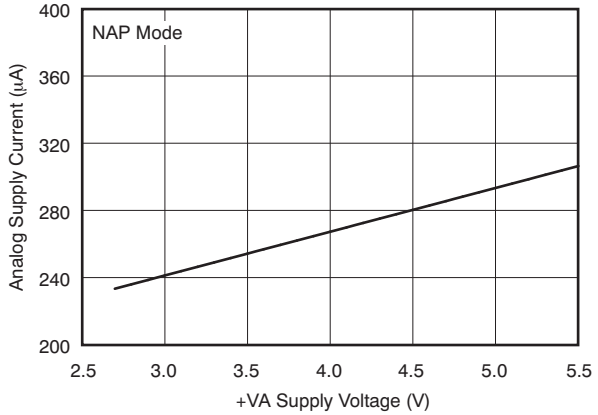


Figure 34.

ANALOG SUPPLY CURRENT vs SUPPLY VOLTAGE

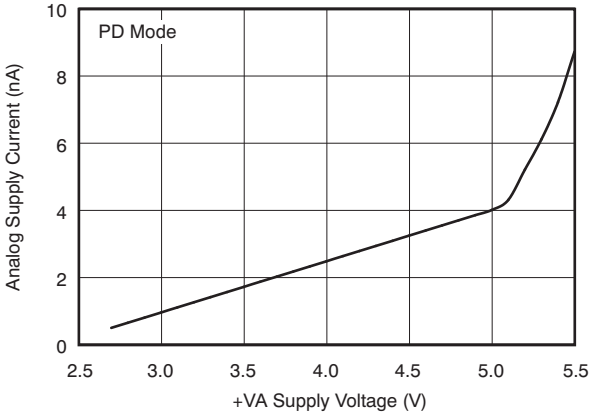


Figure 35.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

ANALOG SUPPLY CURRENT vs SAMPLE RATE

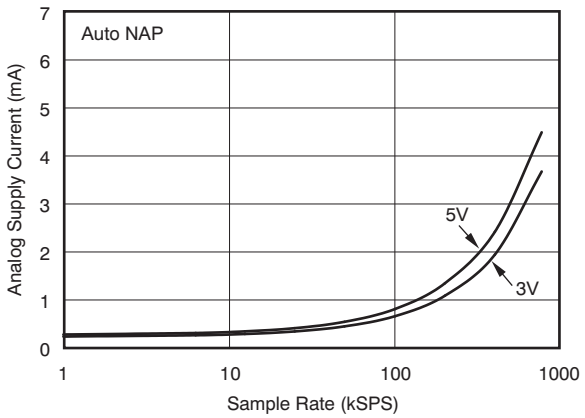


Figure 36.

ANALOG SUPPLY CURRENT vs SAMPLE RATE

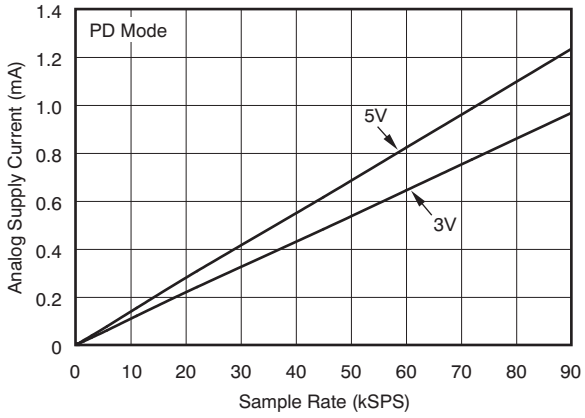


Figure 37.

ANALOG SUPPLY CURRENT vs FREE-AIR TEMPERATURE

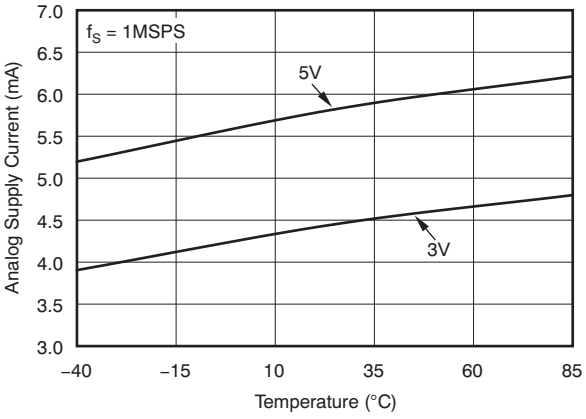


Figure 38.

ANALOG SUPPLY CURRENT vs FREE-AIR TEMPERATURE

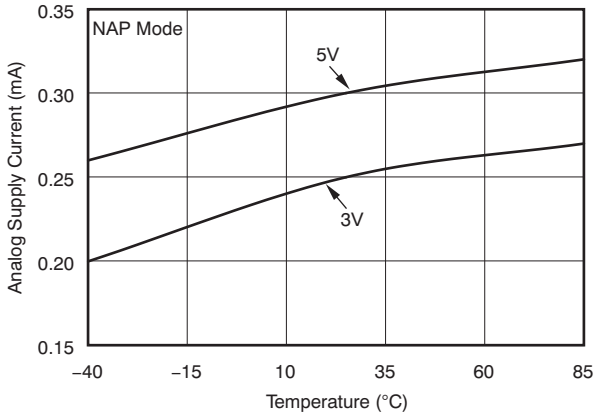


Figure 39.

INTEGRAL NONLINEARITY

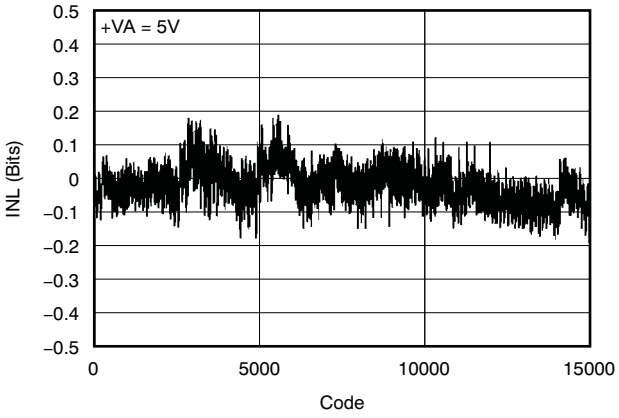


Figure 40.

DIFFERENTIAL NONLINEARITY

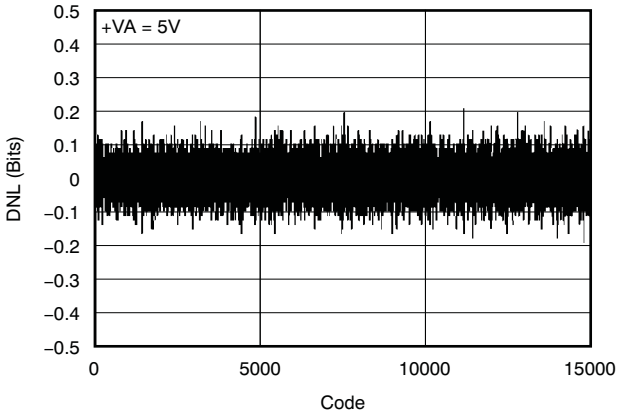


Figure 41.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

INTEGRAL NONLINEARITY

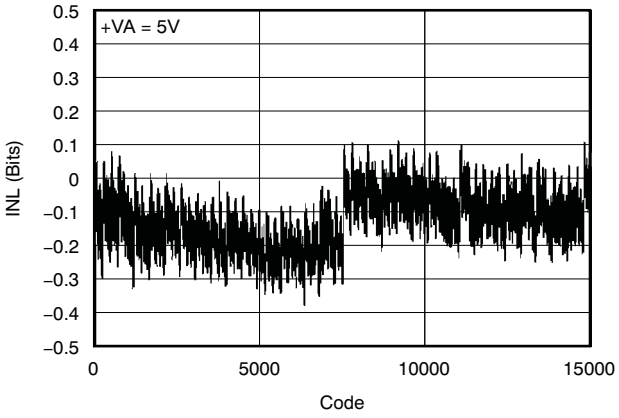


Figure 42.

DIFFERENTIAL NONLINEARITY

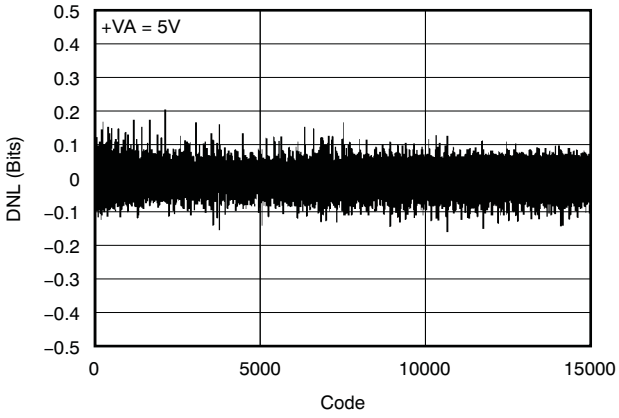


Figure 43.

FFT

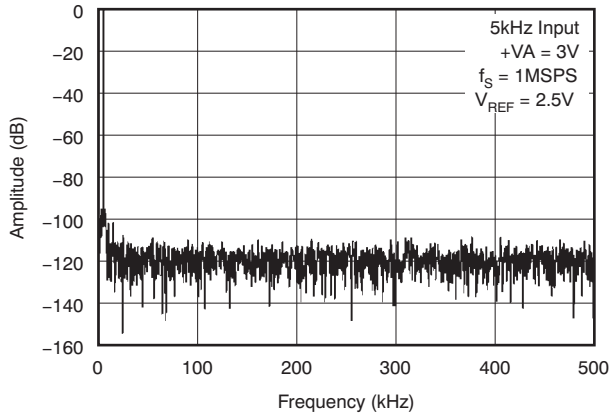


Figure 44.

FFT

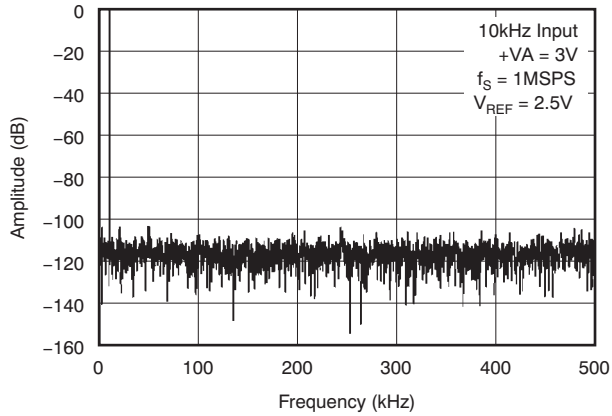


Figure 45.

FFT

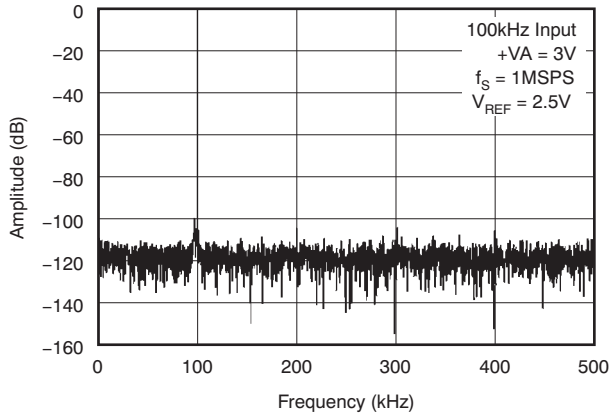


Figure 46.

FFT

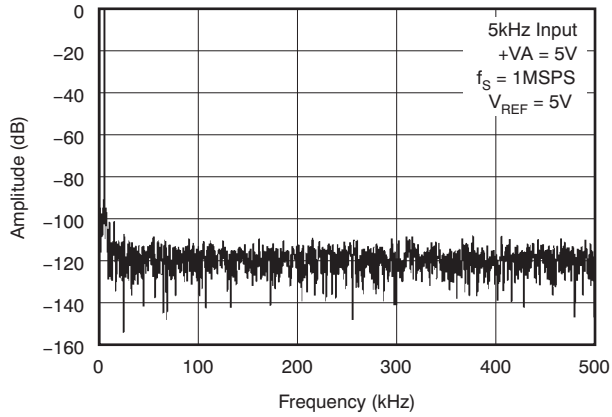


Figure 47.

TYPICAL CHARACTERISTICS (continued)

At –40°C to +85°C, V_{REF} [(REF+) – (REF–)] = 5V when +VA = +VBD = 5V or V_{REF} [(REF+) – (REF–)] = 2.5V when +VA = +VBD = 3V, f_{SCLK} = 42MHz, or V_{REF} = 2.5 when +VA = +VBD = 2.7V, f_{SCLK} = 37.8MHz; f_I = dc for dc curves, f_I = 100kHz for ac curves with 5V supply and f_I = 10kHz for ac curves with 3V supply, unless otherwise noted.

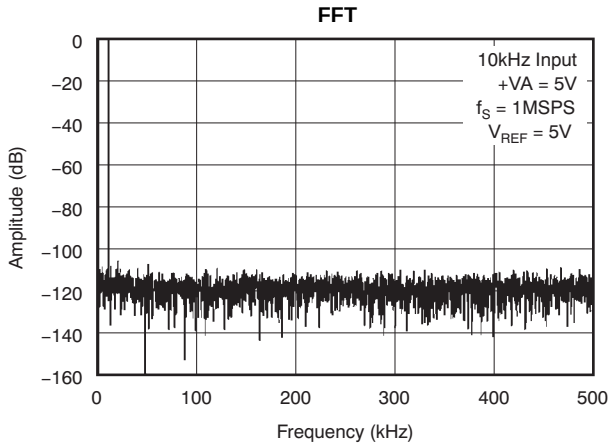


Figure 48.

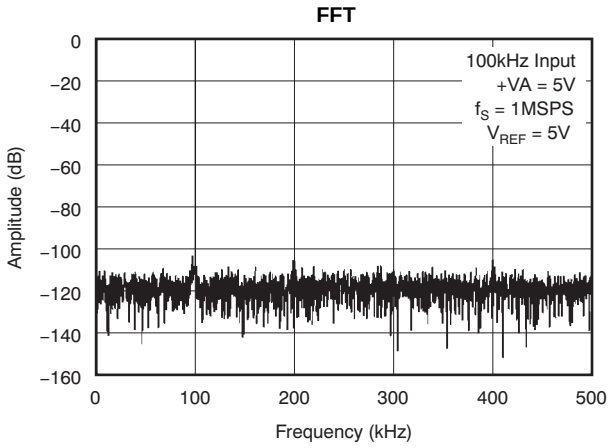


Figure 49.

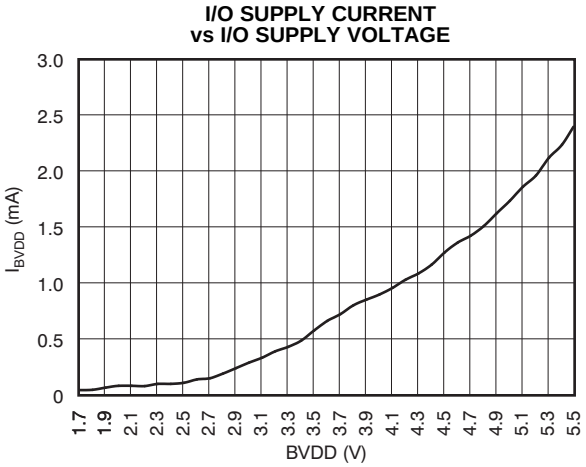


Figure 50.

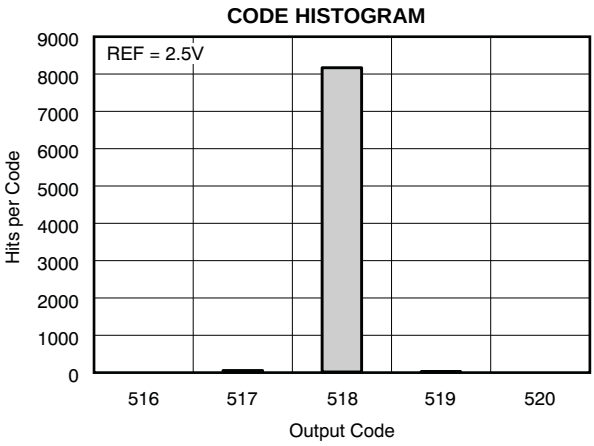


Figure 51.

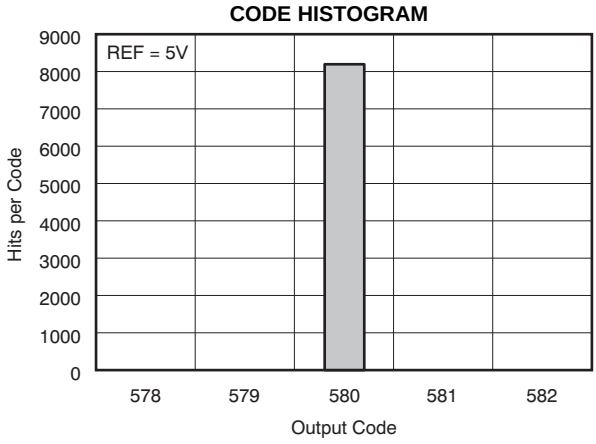


Figure 52.

THEORY OF OPERATION

The ADS7279 and ADS7280 are two high-speed, low-power, successive approximation register (SAR) analog-to-digital converters (ADCs) that use an external reference. The architecture of each device is based on a charge redistribution model that inherently includes a sample-and-hold function.

These devices have an internal clock that runs the conversion; however, these ADCs can also be programmed to convert data based on an external serial clock, SCLK.

The ADS7279 has one analog input. The analog input is provided to two input pins: +IN and –IN. When a conversion is initiated, the differential input on these pins is sampled on the internal capacitor array. While a conversion is in progress, both +IN and –IN inputs are disconnected from any internal function.

The ADS7280 has two inputs. Both inputs share the same common pin, COM. The negative input is the same as the –IN pin for the ADS7279. The ADS7280 can be programmed to select a channel manually, or it can be programmed into the auto channel select mode to sweep between channel 0 and channel 1 automatically.

Throughout this document, the term *ADS7279/80* refers to both devices, unless specifically noted otherwise.

ANALOG INPUT

When the converter enters the hold mode, the voltage difference between the +IN and –IN inputs is captured on the internal capacitor array. The voltage on the –IN input is limited between AGND – 0.2V and AGND + 0.2V, allowing the input to reject small signals that are common to both the +IN and –IN inputs. The +IN input has a range of –0.2V to (V_{REF} + 0.2V). The input span [(+IN) – (–IN)] is limited to 0V to V_{REF}.

The (peak) input current through the analog inputs depends upon a number of factors: sample rate, input voltage, and source impedance. The current into the ADS7279/80 charges the internal capacitor array during the sample period. After this capacitance has been fully charged, there is no further input current. The source of the analog input voltage must be able to charge the input capacitance (45pF) to a 14-bit settling level within the minimum acquisition time (120ns). When the converter goes into hold mode, the input impedance is greater than 1GΩ.

Care must be taken regarding the absolute analog input voltage. To maintain converter linearity, the +IN and –IN inputs and the span [(+IN) – (–IN)] should be within the limits specified. Beyond these ranges, converter linearity may not meet specifications. To minimize noise, low bandwidth input signals with low-pass filters should be used. Care should be taken to ensure that the output impedance of the sources driving the +IN and –IN inputs are matched. If this input matching is not observed, the two inputs could have different settling times. This difference may result in an offset error, gain error, and linearity errors that change with temperature and input voltage.

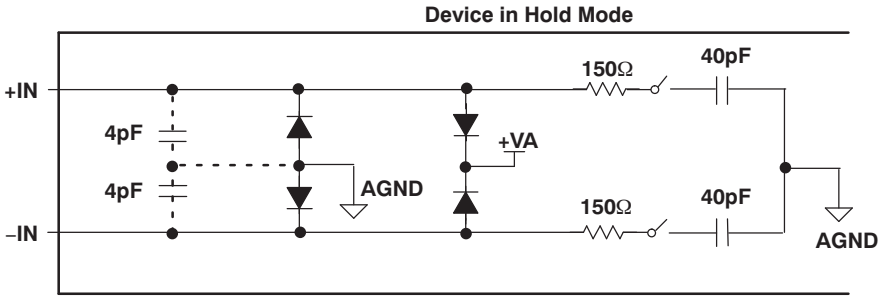


Figure 53. Input Equivalent Circuit

Driver Amplifier Choice

The analog input to the converter must be driven with a low-noise operational amplifier such as the THS4031 or OPA365. An RC filter is recommended at the input pins to low-pass filter the noise from the source. Two 20Ω resistors and a 470pF capacitor are recommended. The input to the converter is a unipolar input voltage in the range of 0V to V_{REF}. The minimum –3dB bandwidth of the driving operational amplifier can be calculated as:

$$f_{3db} = (\ln(2) \times (n+1))/(2\pi \times t_{ACQ})$$

where *n* is equal to 14, the resolution of the ADC (in the case of the ADS7279/80). When t_{ACQ} = 120ns (minimum acquisition time), the minimum bandwidth of the driving amplifier is 13.8MHz. The bandwidth can be relaxed if the acquisition time is increased by the application. Figure 54 shows the THS4031 used in the source follower configuration to drive the converter in a typical input drive configuration. For the ADS7280, a series resistor of 0Ω should be used on the COM input (or no resistor at all).

Bipolar to Unipolar Driver

In systems where the input is bipolar, the THS4031 can be used in an inverting configuration with an additional dc bias applied to its positive input to keep the input to the ADS7279/80 within the rated operating voltage range. This configuration is also recommended when the ADS7279/80 is used in signal processing applications where good SNR and THD performance are required. The dc bias can be derived from the REF5025 or the REF5040 reference voltage ICs. The input configuration shown in Figure 55 is capable of delivering better than 85dB SNR and –100dB THD at an input frequency of 10kHz. If bandpass filters are used to filter the input, care should be taken to ensure that the signal swing at the input of the bandpass filter is small, in order to keep the distortion introduced by the filter minimal. In this case, the gain of the circuit shown in Figure 55 can be increased to keep the input to the ADS7279/80 large in order to maintain a high SNR of the system. Note that the gain of the system from the positive input to the output of the THS4031 in such a configuration is a function of the ac signal gain. A resistor divider can be used to scale the output of the REF5025 or REF5040 to reduce the voltage at the dc input to the THS4031 to maintain the voltage at the converter input within its rated operating range.

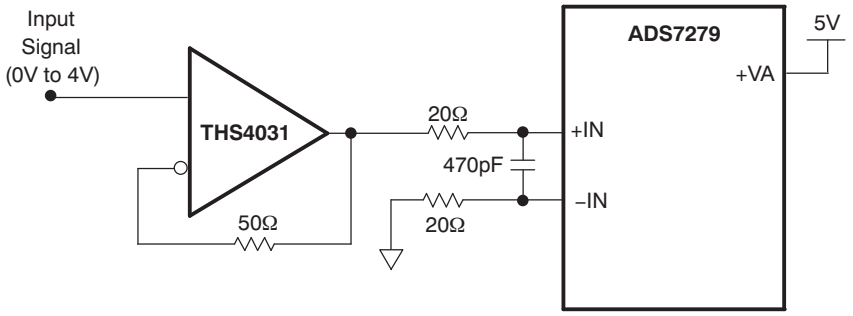


Figure 54. Unipolar Input Drive Configuration

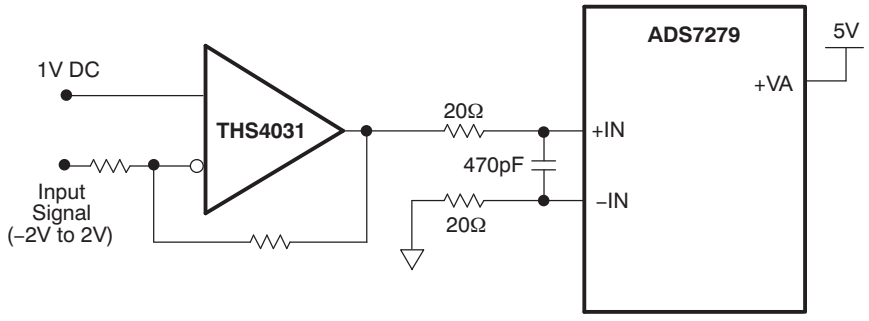


Figure 55. Bipolar Input Drive Configuration

REFERENCE

The ADS7279/80 must operate with an external reference with a range from 0.3V to 5V. A clean, low-noise, well-decoupled reference voltage on the REF+ pin is required to ensure good converter performance. A low-noise bandgap reference such as the REF5040 can be used to drive this pin. A 22µF ceramic decoupling capacitor is required between the REF+ and REF– pins of the converter. These capacitors should be placed as close as possible to the device pins. REF– should be connected with an own via to the analog ground plane with the shortest possible distance. A series resistor between the reference and the REF50xx is neither required (because the REF50xx is capable of driving a 22µF capacitor while maintaining stability) nor recommended (as a result of additional nonlinearity); see also Figure 68.

CONVERTER OPERATION

The ADS7279/80 has an oscillator that is used as an internal clock, which controls the conversion rate. The frequency of this clock is 21MHz (minimum). The oscillator is always on, unless the device is in the deep power-down state or the device is programmed for using SCLK as the conversion clock (CCLK). The minimum acquisition (sampling) time takes 3 CCLKs (equivalent to 143ns at 21MHz) and the conversion time takes 18 conversion clocks (CCLK) or approximately 857ns at 21MHz to complete one conversion.

The conversion can also be programmed to run based on an external serial clock, SCLK. This option allows the designer to fully synchronize the converter with the system. The serial clock SCLK is first reduced to 1/2 of its frequency before it is used as the conversion clock (CCLK). For example, with a 42MHz SCLK, this reduction provides a 21MHz clock for conversions. If it is desired to start a conversion at a specific rising edge of SCLK when the external SCLK is programmed as the source of the conversion clock (and manual conversion start is selected), the setup time between $\overline{\text{CONVST}}$ and that rising SCLK edge should be observed. This configuration ensures that the conversion is complete in 18 CCLKs (or 36 SCLKs). The minimum setup time is 20ns to ensure synchronization between $\overline{\text{CONVST}}$ and SCLK. In many cases, the conversion can start one SCLK period (or CCLK) later, which results in a conversion length of 19 CCLKs (or 37 SCLKs). The 20ns setup time is not required if the synchronization is not critical to the application.

The duty cycle of SCLK is not critical as long as it meets the minimum high and low time requirements of 8ns. The ADS7279/80 is designed for high-speed applications; therefore, a higher serial clock (SCLK) must be supplied to be able to sustain the high throughput with the serial interface. As a result, the clock period of SCLK must be at most 1µs (when used as the conversion clock, CCLK). The minimum clock frequency is also governed by the parasitic leakage of the capacitive digital-to-analog (CDAC) capacitors internal to the ADS7279/80.

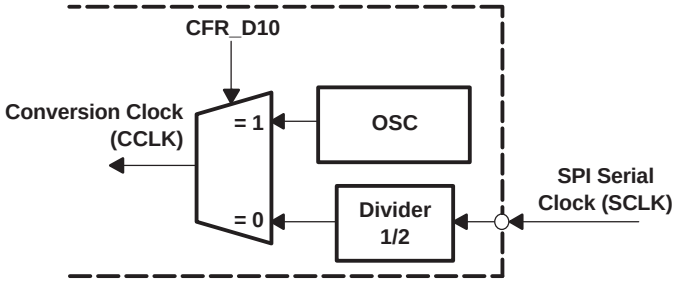


Figure 56. Converter Clock

Manual Channel Select Mode

The conversion cycle starts with selecting an acquisition channel by writing a channel number to the command register, CMR. The command length can be as short as four SCLKs.

Auto Channel Select Mode

Channel selection can also be done automatically if auto channel select mode is enabled. This mode is the default channel select mode. The dual channel converter, ADS7280, has a built-in 2-to-1 MUX. If the device is programmed for auto channel select mode, then signals from channel 0 and channel 1 are acquired with a fixed order. Channel 0 is accessed first in the next cycle after the command cycle that configured CFR_D11 to '1' for auto channel select mode. This automatic access stops the first cycle after the command cycle that sets CFR_D11 to '0'.

Start of a Conversion

The end of sampling instance (EOS) or acquisition is the same as the start of a conversion. This event is initiated by bringing the $\overline{\text{CONVST}}$ pin low for a minimum of 40ns. After the minimum requirement has been met, the $\overline{\text{CONVST}}$ pin can be brought high. $\overline{\text{CONVST}}$ acts independently of FS/$\overline{\text{CS}}$ so it is possible to use one common $\overline{\text{CONVST}}$ for applications that require a simultaneous sample/hold with multiple converters. The ADS7279/80 switches from sample to hold mode on the falling edge of the $\overline{\text{CONVST}}$ signal. The ADS7279/80 requires 18 conversion clock (CCLK) edges to complete a conversion. The conversion time is equivalent to 857ns with a 21MHz internal clock. The minimum time between two consecutive $\overline{\text{CONVST}}$ signals is 21 CCLKs.

A conversion can also be initiated without using $\overline{\text{CONVST}}$ if auto-trigger mode is used (CFR_D9 = 0). When the converter is configured as an auto trigger, the next conversion automatically starts three conversion clocks (CCLK) after the end of a conversion. These three conversion clocks are used as the acquisition time. In this case, the time to complete one acquisition and conversion cycle is 21 CCLKs. Table 1 summarizes the different conversion modes.

Table 1. Different Types of Conversion

MODE	SELECT CHANNEL	START CONVERSION
Automatic	**Auto Channel Select**(1)	**Auto Trigger**
	No need to write channel number to the command register (CMR). Use internal sequencer for the ADS7280.	Start a conversion based on the conversion clock CCLK.
Manual	**Manual Channel Select**	**Manual Trigger**
	Write the channel number to the CMR.	Start a conversion with $\overline{\text{CONVST}}$.

(1) Auto channel select should be used with the TAG bit enabled.

Status Output EOC/$\overline{\text{INT}}$

When the status pin is programmed as EOC and the polarity is set as active low, the pin works in the following manner: The EOC output goes low immediately after $\overline{\text{CONVST}}$ goes low when the manual trigger is programmed. EOC stays low throughout the conversion process and returns high when the conversion ends. The EOC output goes low for three conversion clocks after the previous rising edge of EOC, if auto trigger is programmed.

This status pin is programmable. It can be used as an EOC output (CFR_D[7:6] = 1, 1) where the low time is equal to the conversion time. This status pin can also be used as $\overline{\text{INT}}$ (CFR_D[7:6] = 1, 0), which is set low as the end of a conversion is brought high (cleared) by the next read cycle. The polarity of this pin, used as either function (that is, EOC or $\overline{\text{INT}}$), is programmable through CFR_D7.

Power-Down Modes

The ADS7279/80 has a comprehensive, built-in power-down feature. There are three power-down modes: Deep power-down mode, Nap power-down mode, and Auto nap power-down mode. All three power-down modes are enabled by setting the related CFR bits. The first two power-down modes are activated when enabled. A wakeup command, 1011b, resumes device operation from a power-down mode. Auto nap power-down mode works slightly differently. When the converter is enabled in Auto nap power-down mode, an end of conversion instance (EOC) puts the device into auto nap power-down. The beginning of sampling resumes converter operation. The contents of the configuration register are not affected by any of the power-down modes. Any ongoing conversion when nap or deep power-down is activated is aborted.

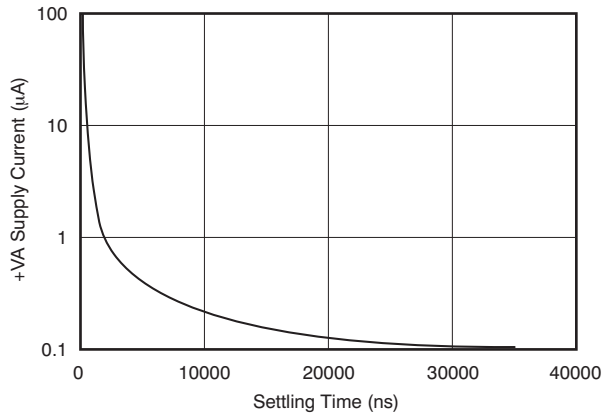


Figure 57. Typical Analog Supply Current Drop vs Time After Power-Down

Deep Power-Down Mode

Deep power-down mode can be activated by writing to configuration register bit CFR_D2. When the device is in Deep power-down mode, all blocks except the interface are in power-down. The external SCLK is internally blocked. Also, all bias currents and the internal oscillator are turned off. In this mode, supply current falls from 5.7mA to 4nA within 100ns. The wake-up time after a deep power-down is 1µs. When bit D2 in the configuration register is set to '0', the device is in Deep power-down. Setting this bit to '1' or sending a wake-up command resumes the converter operation from the Deep power-down state.

Nap Mode

In Nap mode, the ADS7279/80 turns off biasing of the comparator and the mid-voltage buffer. In this mode, supply current falls from 5.7mA in normal mode to about 0.3mA within 200ns after the configuration cycle. The wake-up (resume) time from Nap power-down mode is 3 CCLKs (143ns with a 21MHz conversion clock). As soon as the CFR_D3 bit in the control register is set to '0', the device goes into Nap power-down mode, regardless of the conversion state. Setting this bit to '1' or sending a wake-up command resumes converter operation from the Nap power-down state.

Auto Nap Mode

Auto nap mode is almost identical to nap mode. The only difference is the time when the device is actually powered down and the method used to wake up the device. Configuration register bit D4 is only used to enable/disable Auto nap mode. If Auto nap mode is enabled, the device turns off the biasing after the conversion has finished; that is, the end of conversion activates Auto nap power-down mode. Supply current falls from 5.7mA in normal mode to about 0.3mA within 200ns. A $\overline{\text{CONVST}}$ command resumes the device and turns on the biasing on again in 3 CCLKs (143ns with a 21MHz conversion clock). The device can also be woken up by disabling auto nap mode when bit D4 of the configuration register is set to '1'. Any channel select command 0XXXb, a wake-up command, or the set default mode command 1111b can also wake up the device from Auto nap power-down. Table 2 compares the various power-down modes.

NOTE:

1. This wake-up command is the word *1011b* in the command word. This command sets bits D2 and D3 to '1' in the configuration register, but not D4. A wake-up command removes the device from any of these power-down states, Deep/Nap/Auto nap power-down.
2. Wake-up time is defined as the time between when the host processor tries to wake up the converter and when a conversion start can occur.

Table 2. Power-Down Mode Comparisons

TYPE OF POWER-DOWN	SUPPLY CURRENT AT 5V/3V	POWER-DOWN BY	TIME TO POWER-DOWN (ns)	WAKE-UP BY	WAKE-UP TIME	ENABLE
Normal operation	5.7mA/4.5mA	—	—	—	—	—
Deep power-down	4nA/1nA	Setting CFR	100	Woken up by command 1011b	1µs	Set CFR
Nap power-down	0.3mA/0.25mA	Setting CFR	200	Woken up by command 1011b	3 CCLKs	Set CFR
Auto nap power-down	0.3mA/0.25mA	EOC (end of conversion)	200	Woken up by $\overline{\text{CONVST}}$, any channel select command, default command 1111b, or wake up command 1011b.	3 CCLKs	Set CFR

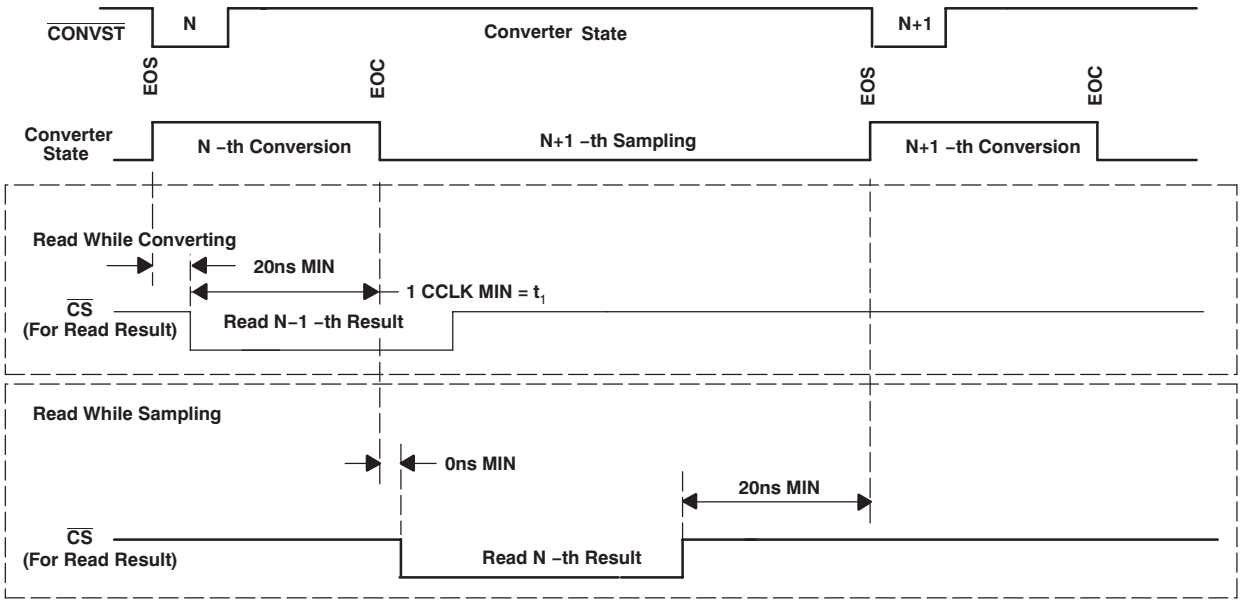


Figure 58. Read While Converting versus Read While Sampling (Manual Trigger)

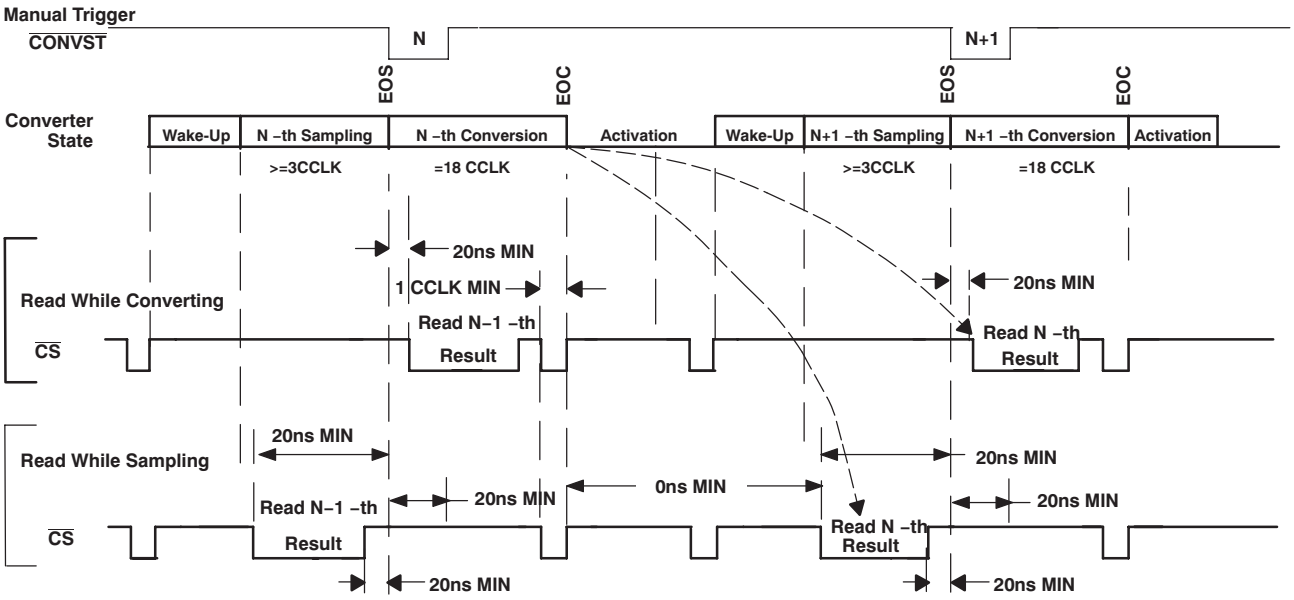


Figure 59. Read While Converting versus Read While Sampling with Deep or Nap Power-Down

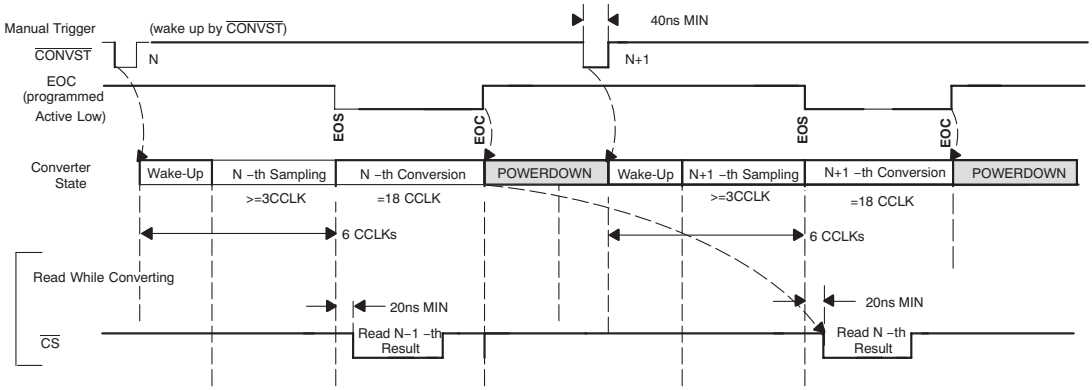


Figure 60. Read While Converting with Auto Nap Power-Down

Total Acquisition + Conversion Cycle Time:

Auto trigger:	= 21 CCLKs
Manual:	≥ 21 CCLKs
Manual + deep power-down:	≥ 4 SCLK + 100µs + 3 CCLK + 18 CCLK +16 SCLK + 1µs
Manual + nap power-down:	≥ 4 SCLK + 3 CCLK + 3 CCLK + 18 CCLK +16 SCLK
Manual + auto nap power-down:	≥ 1 CCLK + 3 CCLK + 3 CCLK + 18 CCLK +16 SCLK (use $\overline{\text{CONVST}}$ to resume)
Manual + auto nap power-down:	≥ 4 SCLK + 3 CCLK + 3 CCLK + 18 CCLK +16 SCLK (use wake up to resume)

DIGITAL INTERFACE

The serial clock is designed to accommodate the latest high-speed processors with an SCLK frequency up to 50MHz. Each cycle starts with the falling edge of FS/$\overline{CS}$. The internal data register content that is made available to the output register at the EOC (presented on the SDO output pin at the falling edge of FS/$\overline{CS}$) is the MSB. Output data are valid at the falling edge of SCLK with a t_{D1} delay so that the host processor can read it at the falling edge. Serial data input is also read at the falling edge of SCLK.

The complete serial I/O cycle starts with the first falling edge of SCLK after the falling edge of FS/$\overline{CS}$ and ends 16 falling edges of SCLK later (see NOTE). The serial interface is very flexible. It works with CPOL = 0 , CPHA = 1 or CPOL = 1, CPHA = 0. This flexibility means the falling edge of FS/$\overline{CS}$ may fall while SCLK is high. The same relaxation applies to the rising edge of FS/$\overline{CS}$ where SCLK may be high or low as long as the last SCLK falling edge occurs before the rising edge of FS/$\overline{CS}$.

NOTE:

There are cases where a cycle is 4 SCLKs or up to 24 SCLKs depending on the read mode combination. See Table 3 and Table 6 for details.

Internal Register

The internal register consists of two parts: 4 bits for the command register (CMR) and 12 bits for configuration data register (CFR). Table 3 summarizes the command set defined by the CMR.

Table 3. Command Set Defined by Command Register (CMR)(1)

D[15:12]	HEX	COMMAND	D[11:0]	WAKE-UP FROM AUTO NAP	MINIMUM SCLKs REQUIRED	R/W
0000b	0h	Select analog input channel 0(2)	Don't care	Y	4	W
0001b	1h	Select analog input channel 1(2)	Don't care	Y	4	W
0010b	2h	Don't care	Don't care	–	–	–
0011b	3h	Don't care	Don't care	–	–	–
0100b	4h	Don't care	Don't care	–	–	–
0101b	5h	Don't care	Don't care	–	–	–
0110b	6h	Don't care	Don't care	–	–	–
0111b	7h	Don't care	Don't care	–	–	–
1000b	8h	Reserved for factory test, don't use	Reserved	–	–	–
1001b	9h	Reserved for factory test, don't use	Reserved	–	–	–
1010b	Ah	Reserved for factory test, don't use	Reserved	–	–	–
1011b	Bh	Wake up	Don't care	Y	4	W
1100b	Ch	Read CFR	Don't care	–	16	R
1101b	Dh	Read data	Don't care	–	14	R
1110	Eh	Write CFR	CFR value	–	16	W
1111b	Fh	Default mode (load CFR with default value)	Don't care	Y	4	W

(1) When SDO is not in 3-state mode (FS/$\overline{CS}$ low), the bits from SDO are always part of a conversion result (depending on how many SCLKs are supplied).

(2) These two commands apply to the ADS7280 only.

WRITING TO THE CONVERTER

There are two different types of writes to the register: a 4-bit write to the CMR and a full 16-bit write to the CMR plus CFR. The command set is listed in Table 3. A simple command requires only 4 SCLKs and the write takes effect at the fourth falling edge of SCLK. A 16-bit write or read takes at least 16 SCLKs (see Table 6 for exceptions that require more than 16 SCLKs).

Configuring the Converter and Default Mode

The converter can be configured with command 1110b (write to the CFR) or command 1111b (default mode). A write to the CFR requires a 4-bit command followed by 12 bits of data. A 4-bit command takes effect at the fourth falling edge of SCLK. A CFR write takes effect at the 16th falling edge of SCLK.

A default mode command can be achieved by simply tying SDI to +VBD. As soon as the chip is selected, at least four '1's are clocked in by SCLK. The default value of the CFR is loaded into the CFR at the fourth falling edge of SCLK.

CFR default values are all 1s (except for CFR_D1 on the ADS7279; this bit is ignored by the device and is always read as a '0'). The same default values apply for the CFR after a power-on reset (POR) and software reset.

READING THE CONFIGURATION REGISTER

The host processor can read back the value programmed in the CFR by issuing command 1100b. The timing is similar to reading a conversion result, except that $\overline{\text{CONVST}}$ is not used and there is no activity on the EOC/$\overline{\text{INT}}$ pin. The CFR value read back contains the first four MSBs of conversion data plus valid 12-bit CFR contents. Table 4 shows the Configuration Register Map.

Table 4. Configuration Register (CFR) Map

SDI BIT		
CFR - D[11 - 0]	DEFINITION	
D11 default = 1	Channel select mode	
	0: Manual channel select enabled. Use channel select commands to access a different channel.	1: Auto channel select enabled. All channels are sampled and converted sequentially until the cycle after this bit is set to 0.
D10 default = 1	Conversion clock (CCLK) source select	
	0: Conversion clock (CCLK) = SCLK/2	1: Conversion clock (CCLK) = Internal OSC
D9 default = 1	Trigger (conversion start) select: start conversion at the end of sampling (EOS). If D9 = 0, the D4 setting is ignored.	
	0: Auto trigger automatically starts (4 internal clocks after EOC inactive)	1: Manual trigger manually started by falling edge of $\overline{\text{CONVST}}$
D8 default = 1	Don't care	Don't care
D7 default = 1	Pin 10 polarity select when used as an output (EOC/$\overline{\text{INT}}$)	
	0: EOC Active high / $\overline{\text{INT}}$ active high	1: EOC active low / $\overline{\text{INT}}$ active low
D6 default = 1	Pin 10 function select when used as an output (EOC/$\overline{\text{INT}}$)	
	0: Pin used as $\overline{\text{INT}}$	1: Pin used as EOC
D5 default = 1	Pin 10 I/O select for chain mode operation	
	0: Pin 10 is used as CDI input (chain mode enabled)	1: Pin 10 is used as EOC/$\overline{\text{INT}}$ output
D4 default = 1	Auto nap power-down enable/disable (mid voltage and comparator shut down between cycles). This bit setting is ignored if D9 = 0.	
	0: Auto nap power-down enabled (not activated)	1: Auto nap power-down disabled
D3 default = 1	Nap power-down (mid voltage and comparator shut down between cycles). This bit is set to 1 automatically by wake-up command.	
	0: Enable/activate device in nap power-down	1: Remove device from nap power-down (resume)
D2 default = 1	Deep power-down. This bit is set to 1 automatically by wake-up command.	
	0: Enable/activate device in deep power-down	1: Remove device from deep power-down (resume)
D1 default = 0: ADS7279 1: ADS7280	TAG bit enable. This bit is ignored by the ADS7279 and is always read 0.	
	0: TAG bit disabled.	1: TAG bit output enabled. TAG bit appears at the 17th SCLK.
D0 default = 1	Reset	
	0: System reset	1: Normal operation

READING CONVERSION RESULT

The conversion result is available to the input of the output data register (ODR) at EOC and presented to the output of the output register at the next falling edge of $\overline{CS}$ or FS. The host processor can then shift the data out via the SDO pin any time except during the quiet zone. This quiet zone is 20ns before and 20ns after the end of sampling (EOS) period. In the quiet zone the FS/CS should be high, to avoid performance loss when switching from sampling-mode to hold-mode. End of sampling (EOS) is defined as the falling edge of $\overline{CONVST}$ when manual trigger is used or the end of the third conversion clock (CCLK) after EOC if auto trigger is used.

The falling edge of FS/$\overline{CS}$ should not be placed at the precise moment of the end of a conversion; otherwise, the data may be corrupt. There must be a minimum of at least one conversion clock (CCLK) delay at the end of a conversion. If FS/$\overline{CS}$ is placed before the end of a conversion, the previous conversion result is read. If FS/$\overline{CS}$ is placed after the end of a conversion, the current conversion result is read.

The conversion result is 14-bit data in straight binary format as shown in Table 5. Generally, 14 SCLKs are necessary, but there are exceptions where more than 14 SCLKS are required (see Table 6). Data output from the serial output (SDO) is left-adjusted, MSB first. The 14-bit conversion result is followed by '00', the TAG bit (if enabled), and additional zeros. SDO remains low until FS/$\overline{CS}$ is brought high again.

Table 5. Ideal Input Voltages and Output Codes

DESCRIPTION	ANALOG VALUE	DIGITAL OUTPUT	
Full-scale range	V_{REF}	STRAIGHT BINARY	
Least significant bit (LSB)	V_{REF}/16384	BINARY CODE	HEX CODE
Full-scale	$+V_{REF}$ – 1LSB	11 1111 1111 1111	3FFF
Midscale	V_{REF}/2	10 0000 0000 0000	2000
Midscale – 1LSB	V_{REF}/2– 1LSB	01 1111 1111 1111	1FFF
Zero	0 V	00 0000 0000 0000	0000

SDO is active when FS/$\overline{CS}$ is low. The rising edge of FS/$\overline{CS}$ 3-states the SDO output.

NOTE:

Whenever SDO is not in 3-state mode (that is, when FS/$\overline{CS}$ is low), a portion of the conversion result is output at the SDO pin. The number of bits depends on how many SCLKs are supplied. For example, a manual select channel command cycle requires 4 SCLKs; therefore, 4MSBs of the conversion result are output at SDO. The exception is that SDO outputs all 1s during the cycle immediately after any reset (POR or software reset).

If SCLK is used as the conversion clock (CCLK) and a continuous SCLK is used, it is not possible to clock out all 14 SDO bits during the sampling time (6 SCLKs) because of the quiet zone requirement. In this case, it is better to read the conversion result during the conversion time (36 SCLKs or 48 SCLKs in Auto nap mode).

TAG Mode

The ADS7280 includes a feature, TAG, that can be used as a tag to indicate which channel sourced the converted result. An address bit is added after the LSB read out from SDO that indicates which channel the result came from if TAG mode is enabled. This address bit is '0' for channel 0 and '1' for channel 1. The converter requires more than the 16 SCLKs that are required for a 4-bit command plus 12-bit CFR or 14 data bits followed by '00' because of the additional TAG bit.

Chain Mode

The ADS7279/80 can operate as a single converter or in a system with multiple converters. System designers can take advantage of the simple, high-speed, SPI-compatible serial interface by cascading the devices in a daisy-chain when multiple converters are used. A bit in the CFR is used to reconfigure the EOC/$\overline{INT}$ status pin as a secondary serial data input, chain data input (CDI), for the conversion result from an upstream converter. This configuration is chain mode operation. A typical connection of three converters is shown in Figure 61.

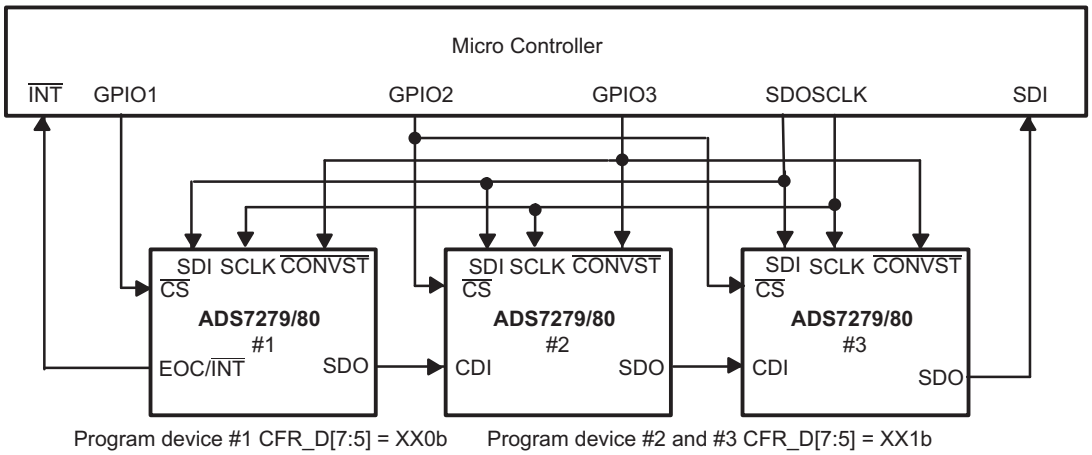


Figure 61. Multiple Converters Connected Using Chain Mode

When multiple converters are used in daisy-chain mode, the first converter is configured in regular mode while the other converters are configured in chain mode. When a converter is configured in chain mode, the CDI input data go straight to the output register; therefore, the serial input data passes through the converter with a 16 SCLK (if the TAG feature is disabled) or a 24 SCLK delay, as long as $\overline{CS}$ is active. Figure 62 shows a detailed timing diagram. In this timing, the conversions in each converter are performed simultaneously.

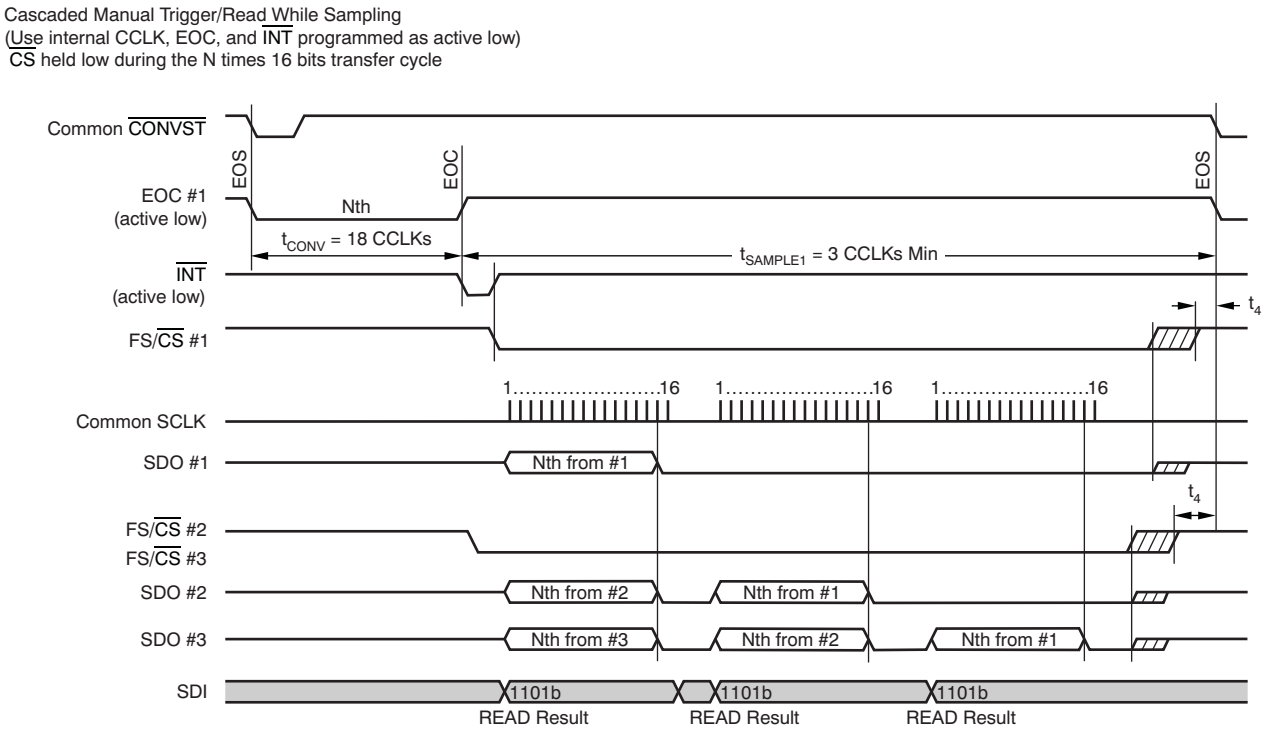


Figure 62. Simplified Cascade Mode Timing with Shared $\overline{CONVST}$ and Continuous $\overline{CS}$

Care must be given to handle the multiple $\overline{CS}$ signals when the converters operate in daisy-chain mode. The different chip select signals must be low for the entire data transfer (in this example, 48 bits for three converters). The first 16-bit word after the falling chip select is always the data from the chip that received the chip select signal.

Case 1: If chip select is not toggled ($\overline{CS}$ stays low), the next 16 bits are data from the upstream converter, and so on. This configuration is shown in Figure 62. If there is no upstream converter in the chain, as with converter #1 in the example, the same data from the converter are going to be shown repeatedly.

Case 2: If the chip select is toggled during a chain mode data transfer cycle, as illustrated in Figure 63, the same data from the converter are read out again and again in all three discrete 16-bit cycles. This result is not a desired outcome.

Cascaded Manual Trigger/Read While Sampling
(Use internal CCLK, EOC, and $\overline{INT}$ programmed as active low)

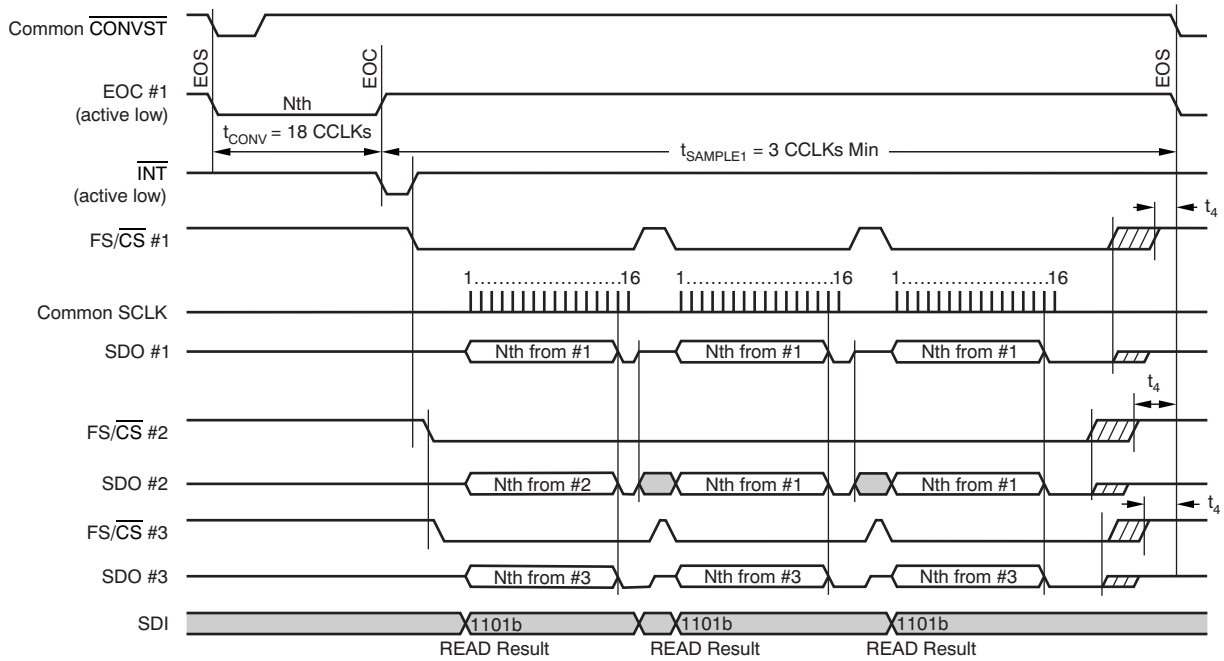


Figure 63. Simplified Cascade Mode Timing with Shared $\overline{CONVST}$ and Discrete $\overline{CS}$

Figure 64 shows a slightly different scenario where $\overline{\text{CONVST}}$ is not shared by the second converter. Converters #1 and #3 have the same $\overline{\text{CONVST}}$ signal. In this case, converter #2 simply passes the previous conversion data downstream.

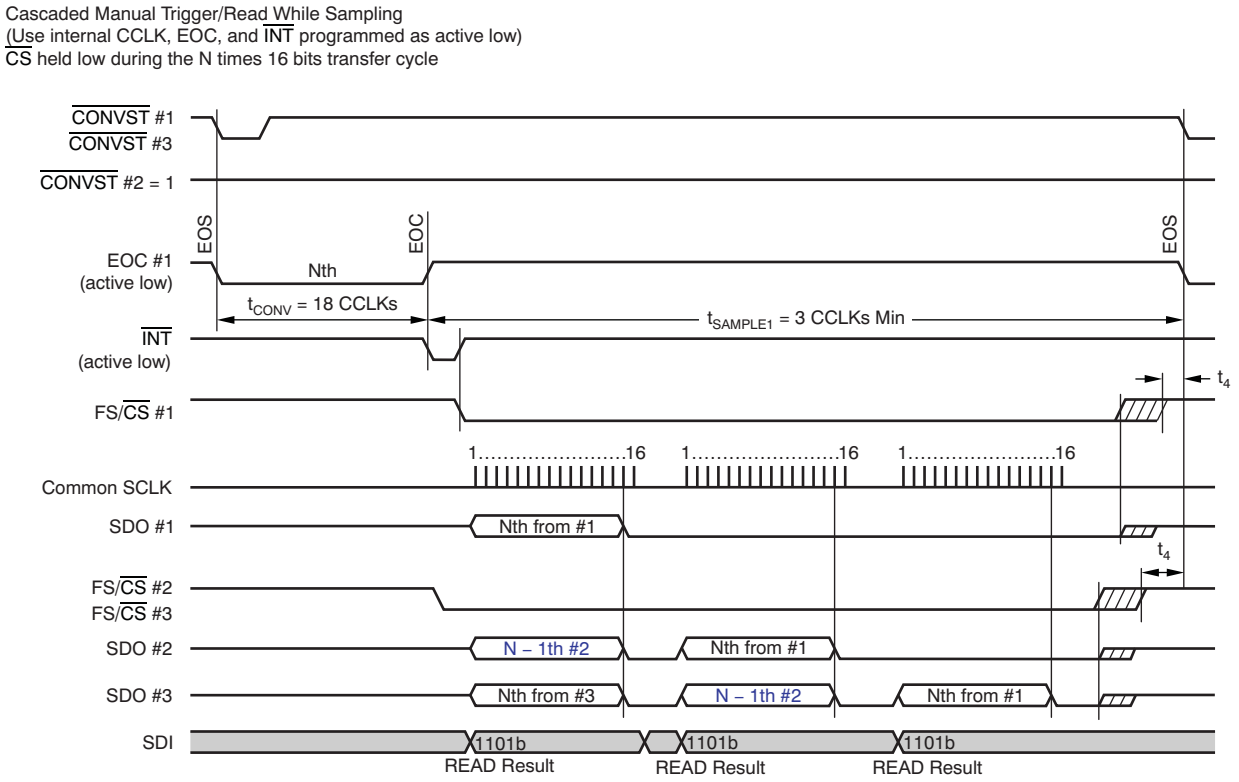


Figure 64. Simplified Cascade Timing (Separate $\overline{\text{CONVST}}$)

The number of SCLKs required for a serial read cycle depends on the combination of different read modes, TAG bit, chain mode, and the way a channel is selected (that is, auto channel select). These possible configurations are listed in Table 6.

Table 6. Required SCLKs For Different Read-Out Mode Combinations

CHAIN MODE ENABLED CFR.D5	AUTO CHANNEL SELECT CFR.D11	TAG ENABLED CFR.D1	NUMBER OF SCLK PER SPI READ	TRAILING BITS
0	0	0	14	None
0	0	1	≥ 17	MSB is TAG bit plus zero(s)
0	1	0	14	None
0	1	1	≥ 17	TAG bit plus seven zeros
1	0	0	16	None
1	0	1	24	TAG bit plus seven zeros
1	1	0	16	None
1	1	1	24	TAG bit plus seven zeros

SCLK skew between converters and data path delay through the converters configured in chain mode can affect the maximum frequency of SCLK. The delay can also be affected by supply voltage and loading. It may be necessary to slow down the SCLK when the devices are configured in chain mode. Figure 65 shows a typical delay process through multiple converters linked in daisy-chain mode.

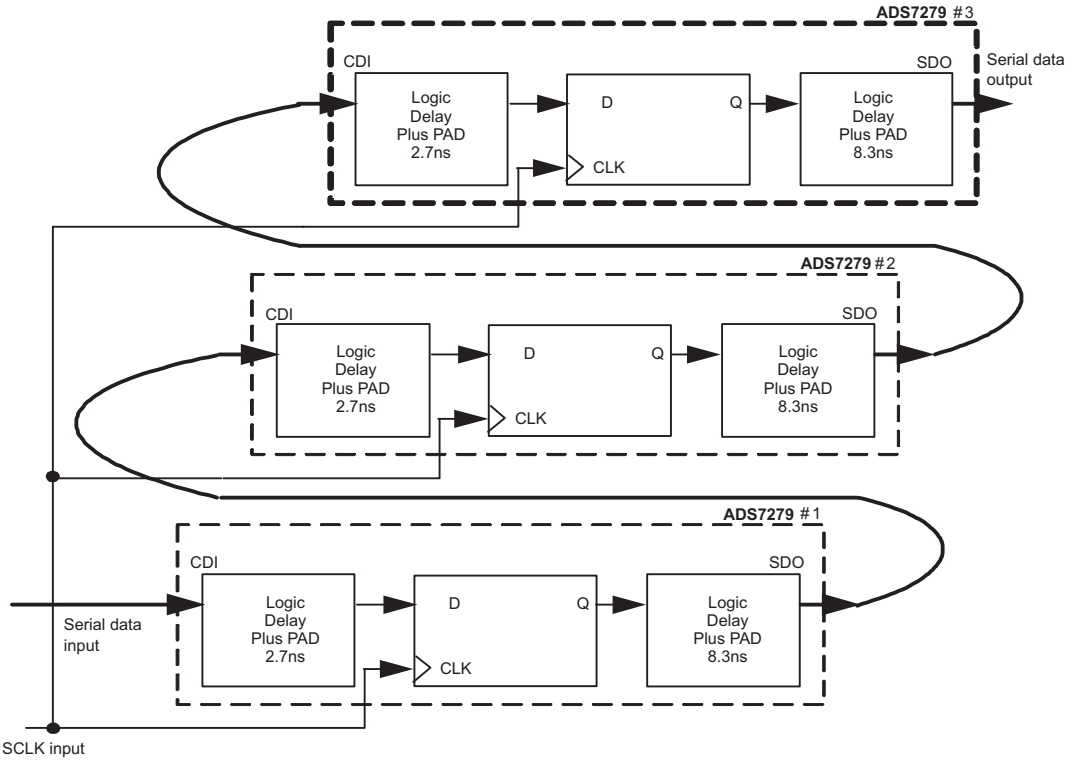


Figure 65. Typical Delay Through Converters Configured in Chain Mode

RESET

The converter has two reset mechanisms: a power-on reset (POR) and a software reset using CFR_D0. These two mechanisms are NOR-ed internally. When a reset (software or POR) is issued, all register data are set to the default values (all 1s) and the SDO output (during the cycle immediately after reset) is set to all 1s. The state machine is reset to the power-on state. Figure 66 illustrates the digital output under a reset condition.

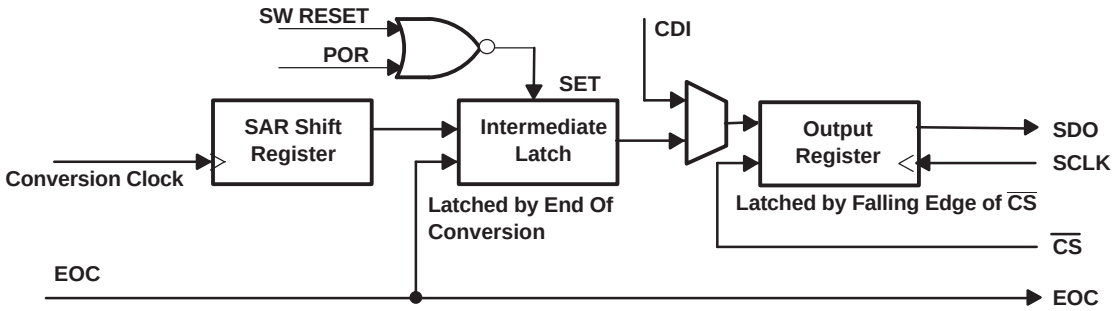


Figure 66. Digital Output Under Reset Condition

When the device is powered up, the POR sets the device to default mode when AVDD reaches 1.5V. When the device is powered down, the POR circuit requires AVDD to remain below 125mV for at least 350ms to ensure proper discharging of internal capacitors and to correct the behavior of the ADC when powered up again. If AVDD drops below 400mV but remains above 125mV, the internal POR capacitor does not discharge fully and the device requires a software reset to perform correctly after the recovery of AVDD (this condition is shown as the *undefined zone* in Figure 67).

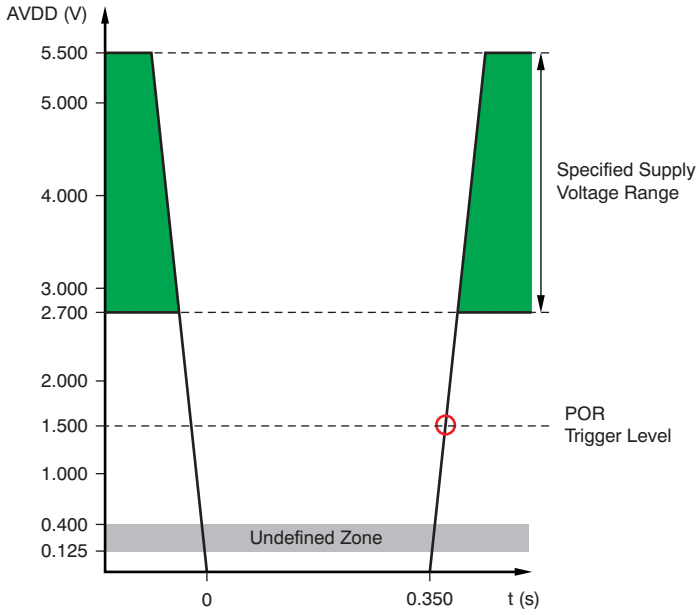


Figure 67. Relevant Voltage Levels for POR

APPLICATION INFORMATION

TYPICAL CONNECTION

Figure 68 shows a typical circuit configuration for the device.

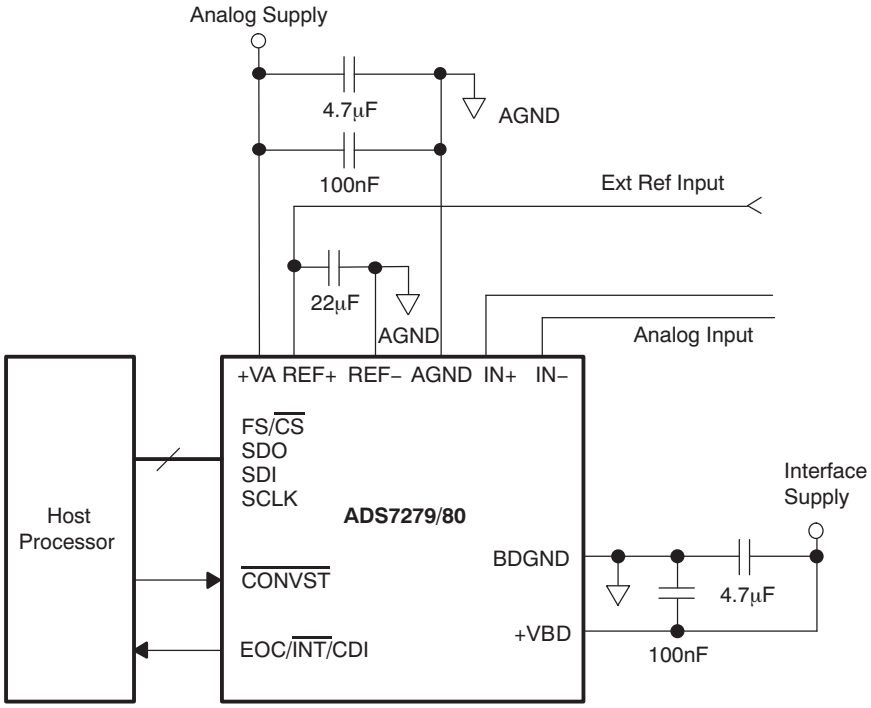


Figure 68. Typical Circuit Configuration

Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Original (May 2008) to Revision A **Page**

- Added *+REF to AGND* and *–REF to AGND* specifications to voltage range section of *Absolute Maximum Ratings* table .. 2
- Changed conditions of the 5V *Electrical Characteristics* to include *+VA = 4.5V to 5.5V* 3
- Changed conditions of the 5V *Electrical Characteristics* to include *+VA = 4.5V to 5.5V* 4
- Deleted typical specification for V_{REF}[REF+ – (REF–)] input reference range in the External Voltage Reference Input section of the 5V *Electrical Characteristics* 4
- Changed test condition of PD mode, *supply current* row of the Power-Supply Requirements section of the 5V *Electrical Characteristics* 4
- Changed the V_{REF} rows of the External Voltage Reference Input section of the 2.5V *Electrical Characteristics* 6
- Changed test condition of PD mode, *supply current* row of the Power-Supply Requirements section of the 2.5V *Electrical Characteristics* 7
- Corrected typo in Figure 2 12
- Corrected typo in Figure 3 13
- Corrected typo in Figure 5 14
- Added last sentence to the *Driver Amplifier Choice* section 24
- Updated Figure 54 24
- Updated Figure 55 24
- Changed fifth sentence of *Deep Power-Down Mode* section 27
- Added supply current value to Auto-nap power-down row of Table 2 28
- Added Figure 67 and corresponding paragraph to the *RESET* section 37

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
ADS7279IPW	Active	Production	TSSOP (PW) | 16	90 | TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IPW.A	Active	Production	TSSOP (PW) | 16	90 | TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IPWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IPWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IRSAR	Active	Production	QFN (RSA) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IRSAR.A	Active	Production	QFN (RSA) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IRSAT	Active	Production	QFN (RSA) | 16	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7279IRSAT.A	Active	Production	QFN (RSA) | 16	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7279I A
ADS7280IPW	Active	Production	TSSOP (PW) | 16	90 | TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IPW.A	Active	Production	TSSOP (PW) | 16	90 | TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IPWR	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IPWR.A	Active	Production	TSSOP (PW) | 16	2000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IRSAR	Active	Production	QFN (RSA) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IRSAR.A	Active	Production	QFN (RSA) | 16	3000 | LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IRSAT	Active	Production	QFN (RSA) | 16	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A
ADS7280IRSAT.A	Active	Production	QFN (RSA) | 16	250 | SMALL T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	ADS 7280I A

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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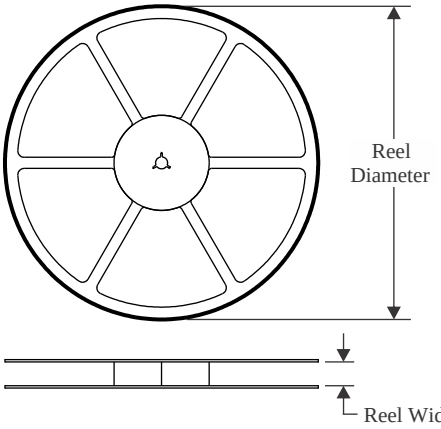
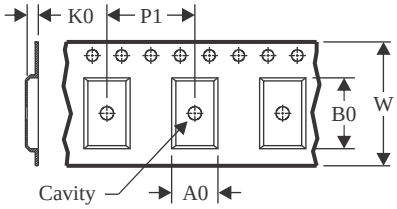
TAPE AND REEL INFORMATION

REEL DIMENSIONS

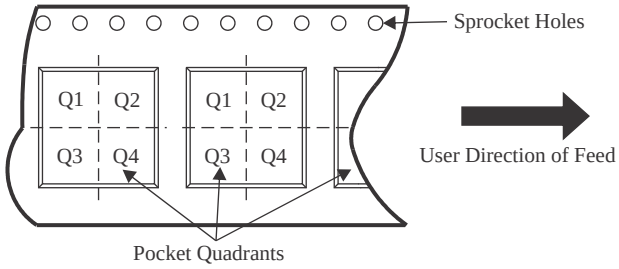


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

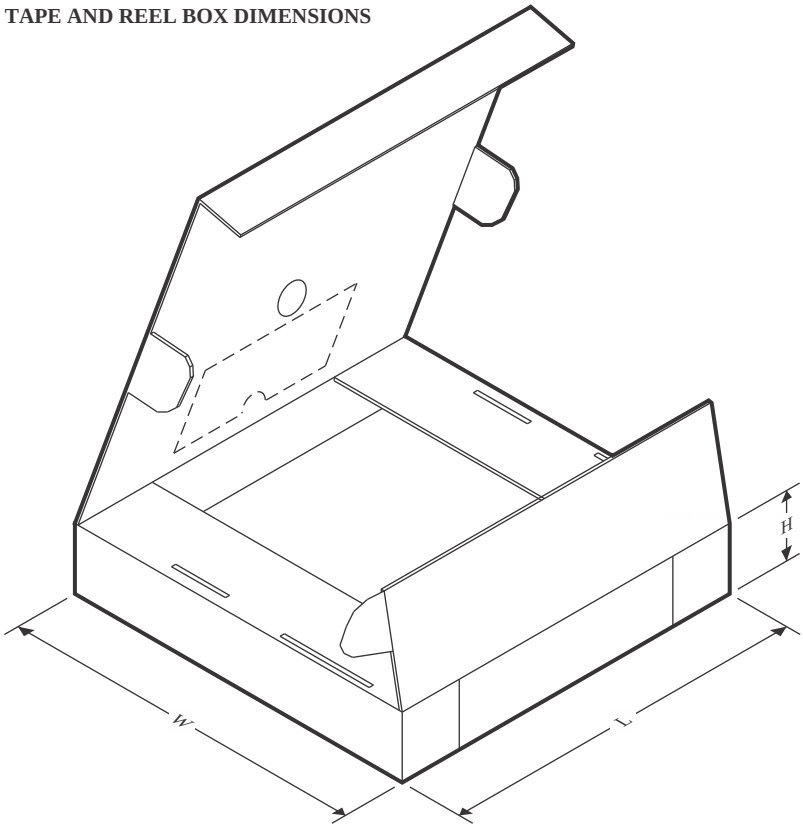
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADS7279IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
ADS7279IRSAR	QFN	RSA	16	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q2
ADS7279IRSAT	QFN	RSA	16	250	180.0	12.4	4.3	4.3	1.5	8.0	12.0	Q2
ADS7280IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
ADS7280IRSAR	QFN	RSA	16	3000	330.0	12.4	4.3	4.3	1.5	8.0	12.0	Q2
ADS7280IRSAT	QFN	RSA	16	250	180.0	12.4	4.3	4.3	1.5	8.0	12.0	Q2

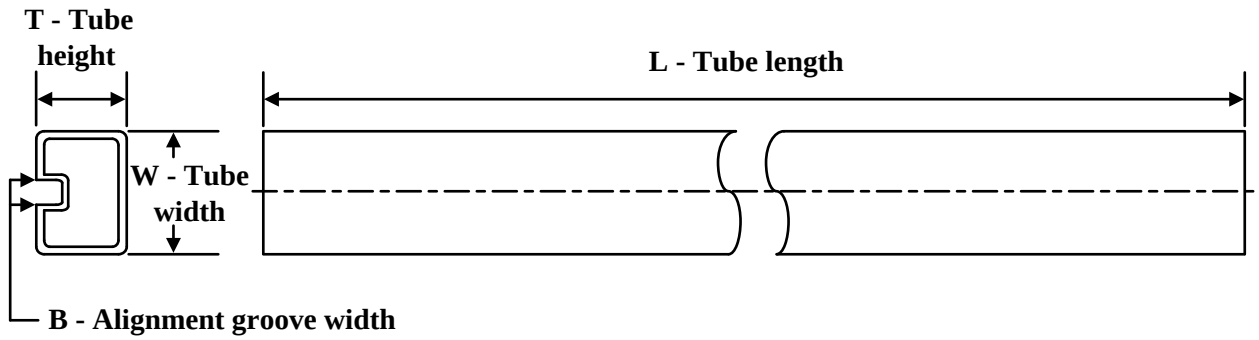
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADS7279IPWR	TSSOP	PW	16	2000	350.0	350.0	43.0
ADS7279IRSAR	QFN	RSA	16	3000	350.0	350.0	43.0
ADS7279IRSAT	QFN	RSA	16	250	210.0	185.0	35.0
ADS7280IPWR	TSSOP	PW	16	2000	350.0	350.0	43.0
ADS7280IRSAR	QFN	RSA	16	3000	350.0	350.0	43.0
ADS7280IRSAT	QFN	RSA	16	250	210.0	185.0	35.0

TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
ADS7279IPW	PW	TSSOP	16	90	530	10.2	3600	3.5
ADS7279IPW.A	PW	TSSOP	16	90	530	10.2	3600	3.5
ADS7280IPW	PW	TSSOP	16	90	530	10.2	3600	3.5
ADS7280IPW.A	PW	TSSOP	16	90	530	10.2	3600	3.5

GENERIC PACKAGE VIEW

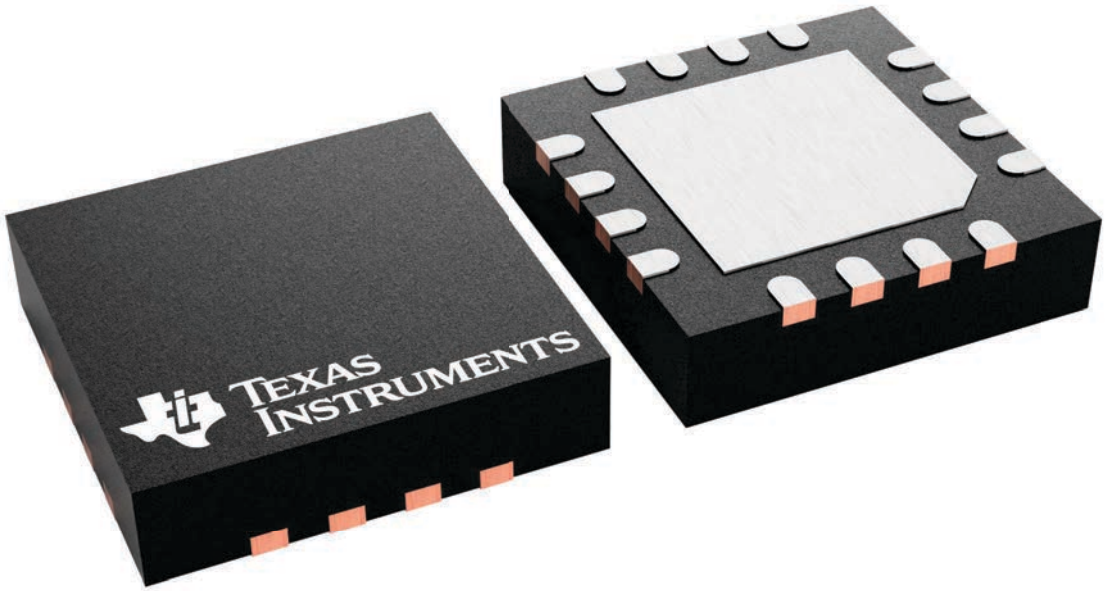
RSA 16

VQFN - 1 mm max height

4 x 4, 0.65 mm pitch

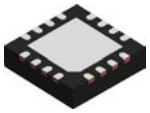
PLASTIC QUAD FLATPACK - NO LEAD

This image is a representation of the package family, actual package may vary.
Refer to the product data sheet for package details.



4230969/A

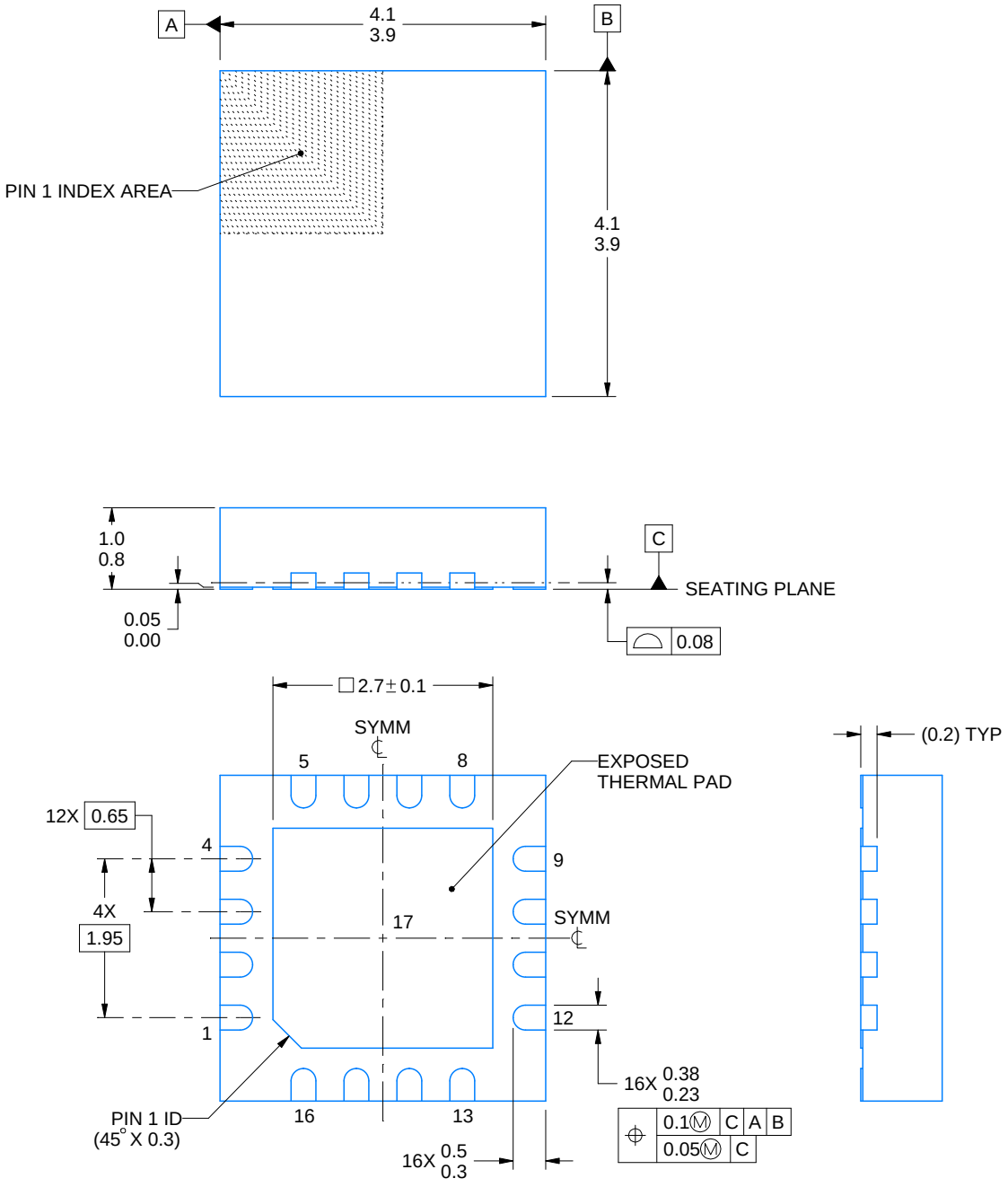
RSA0016B



PACKAGE OUTLINE

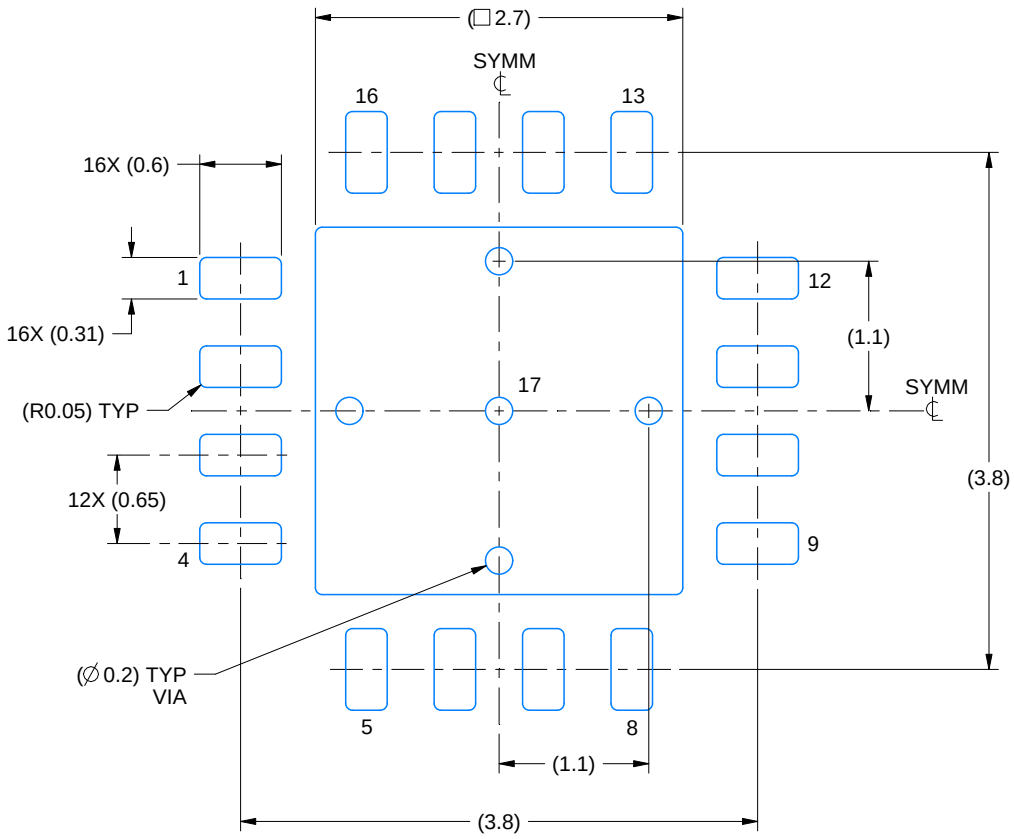
VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD

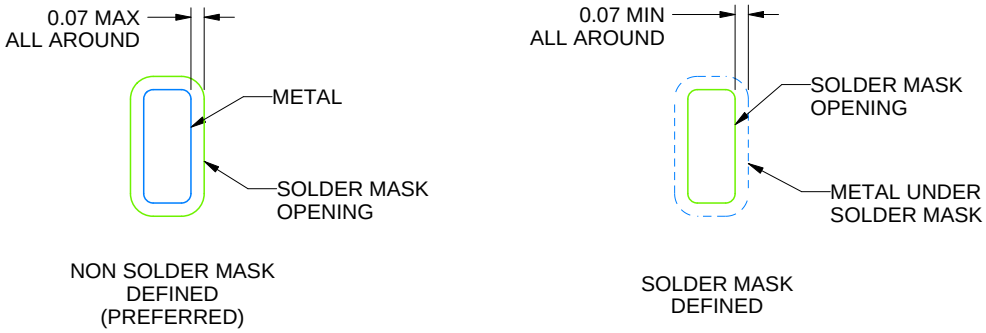


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
4. Reference JEDEC registration MO-220.



LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE:18X

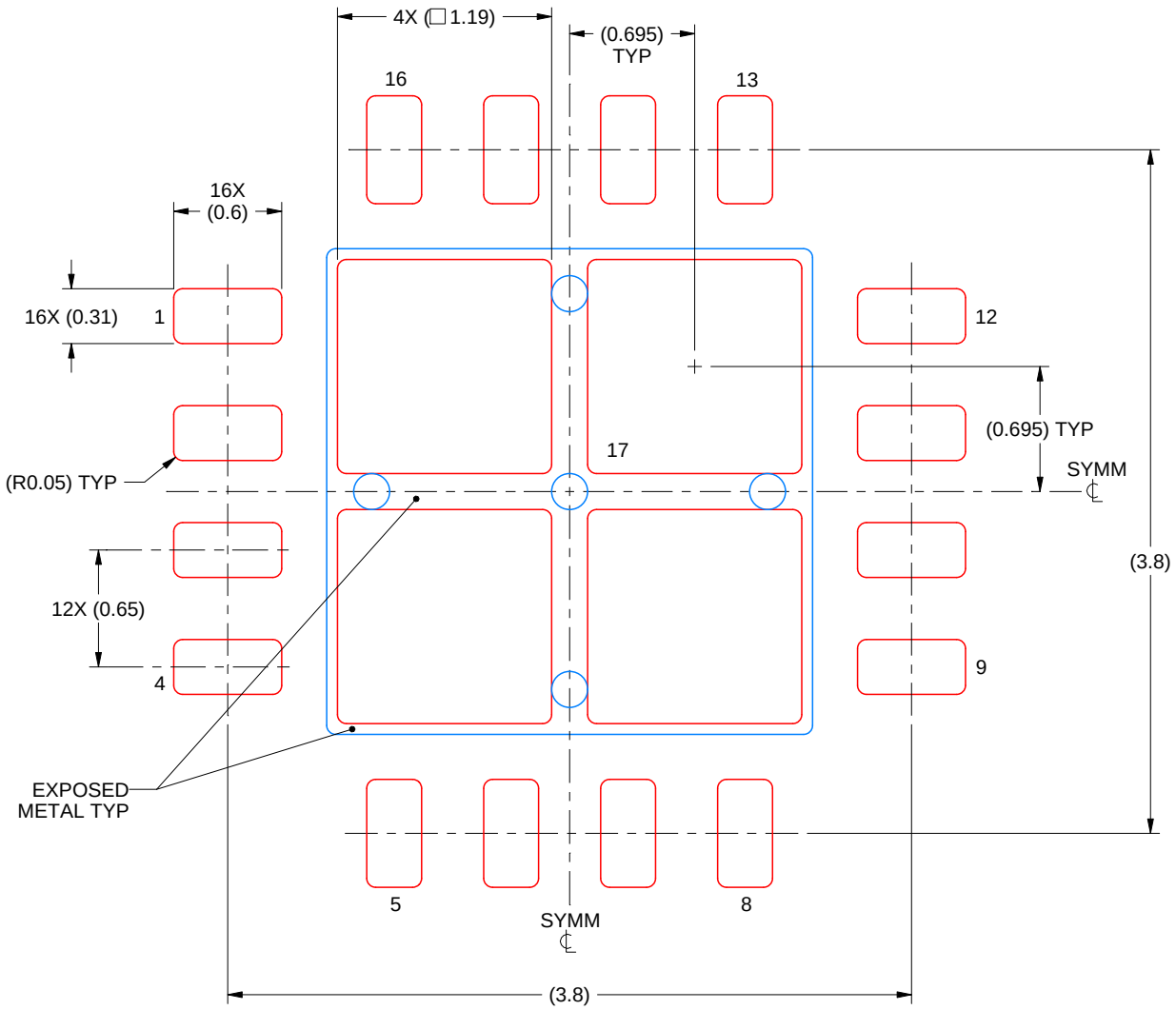


SOLDER MASK DETAILS

4219093/A 08/2021

NOTES: (continued)

5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).
6. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD
77% PRINTED SOLDER COVERAGE BY AREA
SCALE:25X

4219093/A 08/2021

NOTES: (continued)

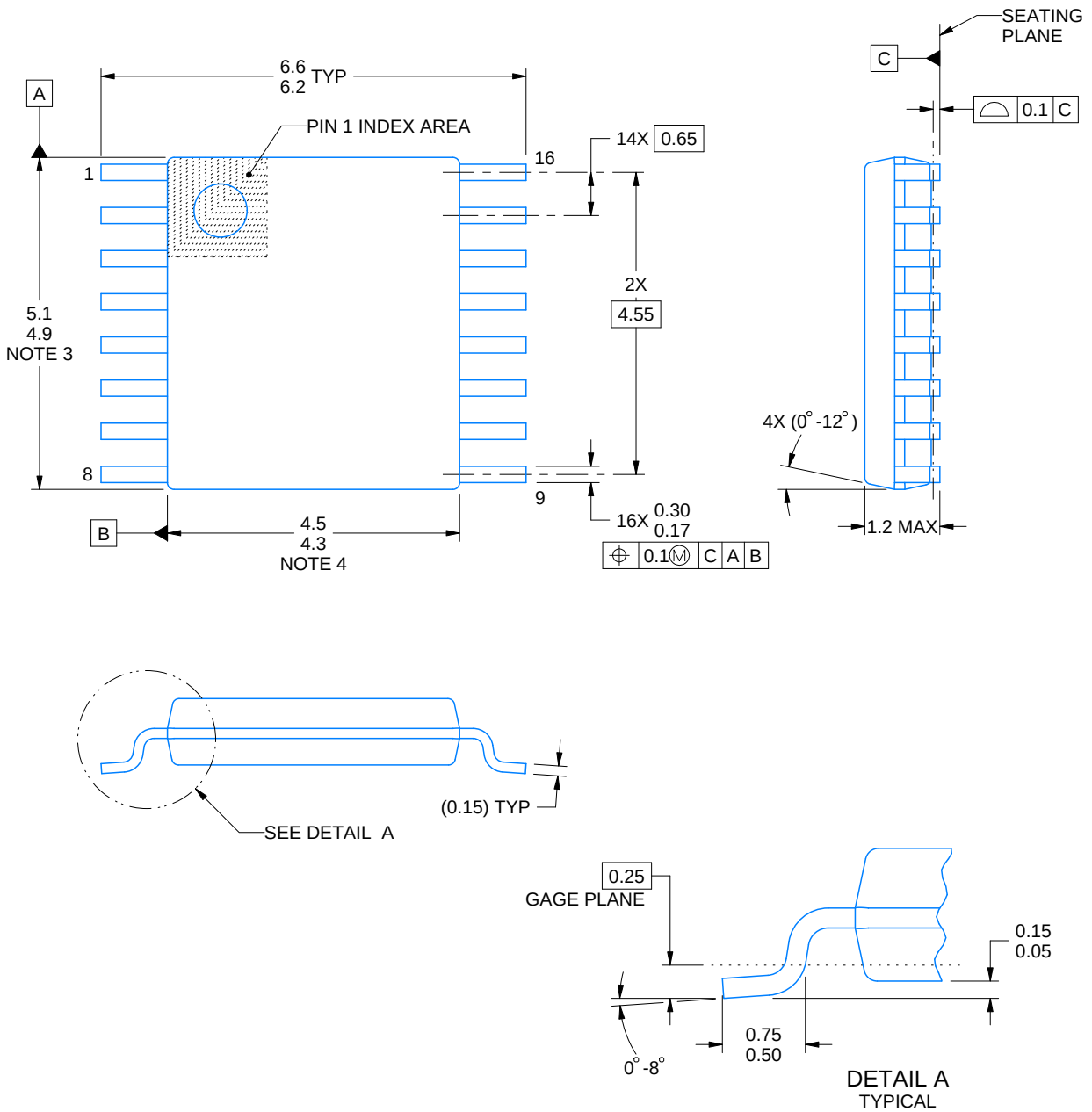
7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

PACKAGE OUTLINE

PW0016A

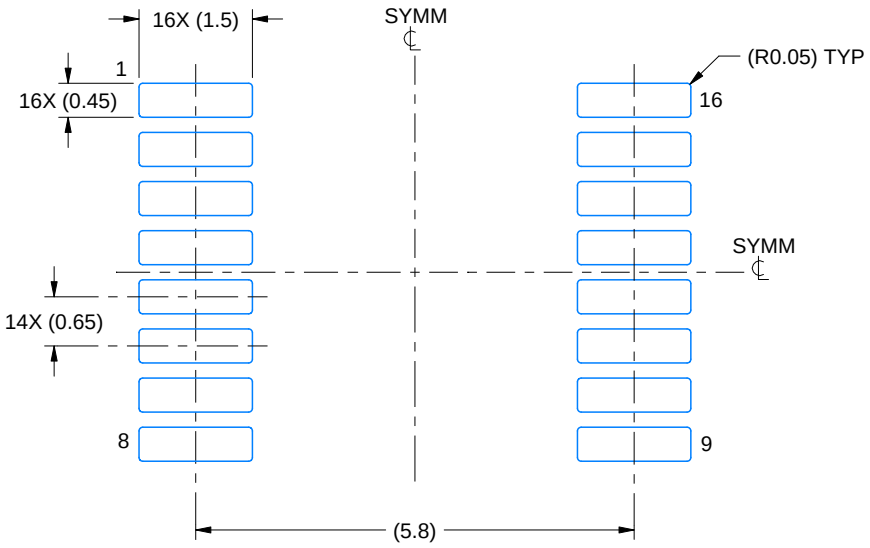
TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.



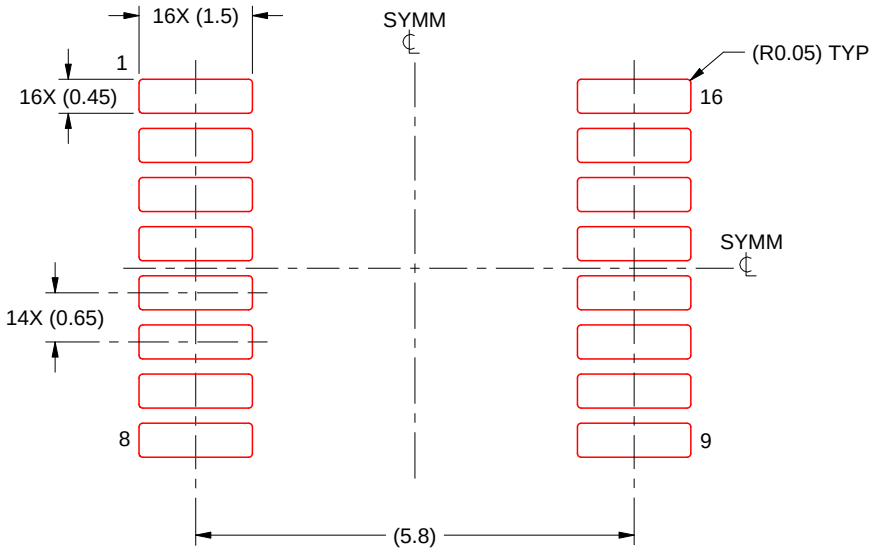
LAND PATTERN EXAMPLE
EXPOSED METAL SHOWN
SCALE: 10X

SOLDER MASK DETAILS

4220204/B 12/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SOLDER PASTE EXAMPLE
BASED ON 0.125 mm THICK STENCIL
SCALE: 10X

4220204/B 12/2023

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

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